



## ADS4128 12-Bit, 200-MSPS, Ultralow-Power ADC

### 1 Features

- Maximum Sample Rate: 200 MSPS
- Ultralow Power with 1.8-V Single Supply:
  - 230-mW Total Power at 200 MSPS
- High Dynamic Performance:
  - SNR: 69 dBFS at 170 MHz
  - SFDR: 85 dBc at 170 MHz
- Dynamic Power Scaling With Sample Rate
- Output Interface:
  - Double Data Rate (DDR) LVDS with Programmable Swing and Strength
  - Standard Swing: 350 mV
  - Low Swing: 200 mV
  - Default Strength: 100- $\Omega$  Termination
  - 2 $\times$  Strength: 50- $\Omega$  Termination
  - 1.8-V Parallel CMOS Interface Also Supported
- Programmable Gain up to 6 dB for SNR and SFDR Trade-Off
- DC Offset Correction
- Supports Low Input Clock Amplitude Down to 200 mV<sub>PP</sub>
- Package: 7.00 mm  $\times$  7.00 mm VQFN-48

### 2 Applications

- Wireless Communications Infrastructure
- Software-Defined Radio
- Power Amplifier Linearization

### 3 Description

The ADS4128 is a 12-bit analog-to-digital converter (ADC) with sampling rates up to 200 MSPS. This device uses innovative design techniques to achieve high dynamic performance, while consuming extremely low power at 1.8-V supply. The device is well-suited for multi-carrier, wide-bandwidth communications applications.

The ADS4128 has fine-gain options that can be used to improve SFDR performance at lower full-scale input ranges, especially at high input frequencies. It includes a dc offset correction loop that can be used to cancel the ADC offset. At lower sampling rates, the ADC automatically operates at scaled-down power with no loss in performance.

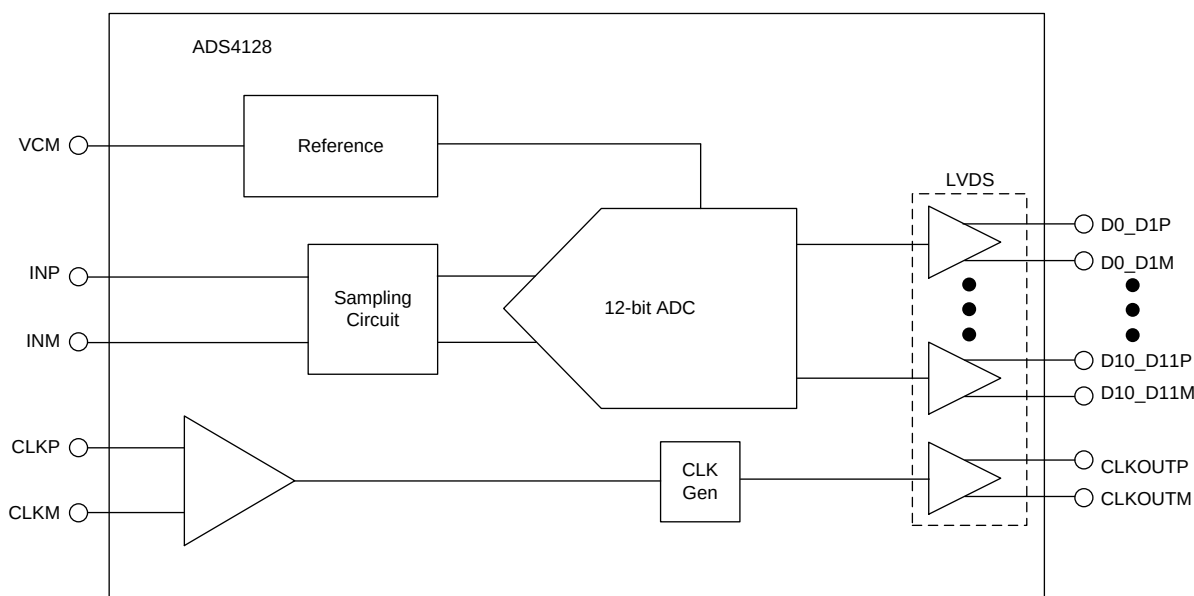
The ADS4128 is available in a compact VQFN-48 package and is specified over the industrial temperature range ( $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ ).

#### Device Information<sup>(1)</sup>

| PART NUMBER | PACKAGE  | BODY SIZE (NOM)          |
|-------------|----------|--------------------------|
| ADS4128     | VQFN(48) | 7.00 mm $\times$ 7.00 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

ADS4128 Block Diagram



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## 4 Revision History

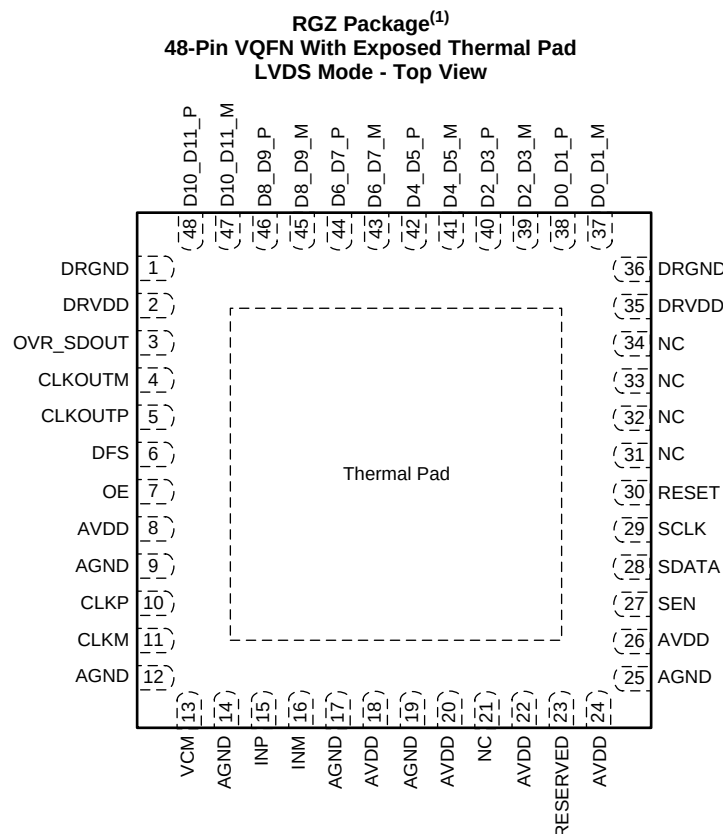
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from Original (May 2012) to Revision A                                                                                                                                                                                                                                                                                                                                                      | Page     |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------|
| <ul style="list-style-type: none"> <li>Added <i>ESD Ratings</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i>, <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section. ....</li> </ul> | <b>1</b> |

## 5 Device Comparison Table

| FAMILY                   | SAMPLING RATE           |                         |                         |                         |                         | WITH ANALOG INPUT BUFFERS |                          |
|--------------------------|-------------------------|-------------------------|-------------------------|-------------------------|-------------------------|---------------------------|--------------------------|
|                          | 65 MSPS                 | 125 MSPS                | 160 MSPS                | 200 MSPS                | 250 MSPS                | 200 MSPS                  | 250 MSPS                 |
| ADS412x<br>12-bit family | <a href="#">ADS4122</a> | <a href="#">ADS4125</a> | <a href="#">ADS4126</a> | <a href="#">ADS4128</a> | <a href="#">ADS4129</a> | —                         | <a href="#">ADS41B29</a> |
| ADS414x<br>14-bit family | <a href="#">ADS4142</a> | <a href="#">ADS4145</a> | <a href="#">ADS4146</a> | —                       | <a href="#">ADS4149</a> | —                         | <a href="#">ADS41B49</a> |
| 9-bit                    | —                       | —                       | —                       | —                       | —                       | —                         | <a href="#">ADS58B19</a> |
| 11-bit                   | —                       | —                       | —                       | —                       | —                       | <a href="#">ADS58B18</a>  | —                        |

## 6 Pin Configuration and Functions



The thermal pad is connected to DRGND.

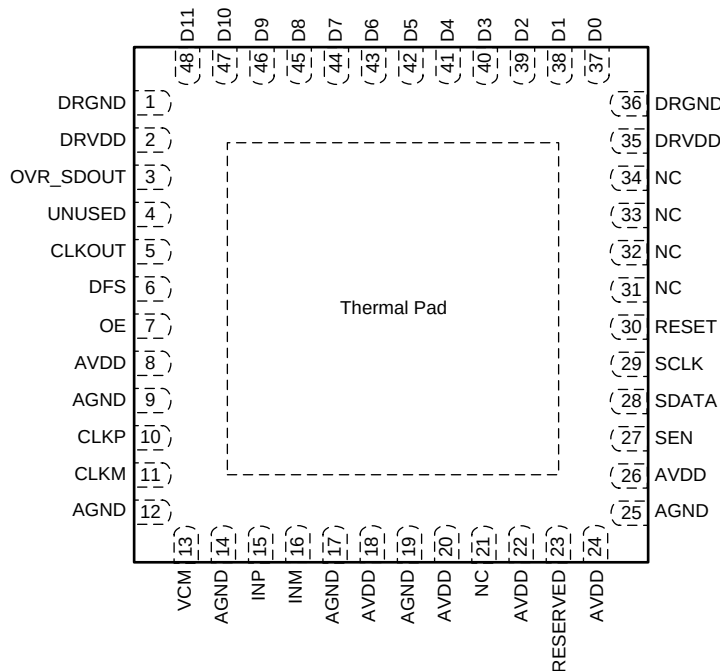
### Pin Functions - LVDS Mode

| PIN       |                       | I/O | DESCRIPTION                                                                                                                                                                                   |
|-----------|-----------------------|-----|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME      | NO.                   |     |                                                                                                                                                                                               |
| AGND      | 9, 12, 14, 17, 19, 25 | I   | Analog ground                                                                                                                                                                                 |
| AVDD      | 8, 18, 20, 22, 24, 26 | I   | 1.8-V analog power supply                                                                                                                                                                     |
| CLKM      | 11                    | I   | Differential clock input, negative                                                                                                                                                            |
| CLKP      | 10                    | I   | Differential clock input, positive                                                                                                                                                            |
| CLKOUTM   | 4                     | O   | Differential output clock, negative                                                                                                                                                           |
| CLKOUTP   | 5                     | O   | Differential output clock, positive                                                                                                                                                           |
| D0_D1_P   | 38                    | O   | Differential output data D0 and D1 multiplexed, true                                                                                                                                          |
| D0_D1_M   | 37                    | O   | Differential output data D0 and D1 multiplexed, complement                                                                                                                                    |
| D2_D3_P   | 40                    | O   | Differential output data D2 and D3 multiplexed, true                                                                                                                                          |
| D2_D3_M   | 39                    | O   | Differential output data D2 and D3 multiplexed, complement                                                                                                                                    |
| D4_D5_P   | 42                    | O   | Differential output data D4 and D5 multiplexed, true                                                                                                                                          |
| D4_D5_M   | 41                    | O   | Differential output data D4 and D5 multiplexed, complement                                                                                                                                    |
| D6_D7_P   | 44                    | O   | Differential output data D6 and D7 multiplexed, true                                                                                                                                          |
| D6_D7_M   | 43                    | O   | Differential output data D6 and D7 multiplexed, complement                                                                                                                                    |
| D8_D9_P   | 46                    | O   | Differential output data D8 and D9 multiplexed, true                                                                                                                                          |
| D8_D9_M   | 45                    | O   | Differential output data D8 and D9 multiplexed, complement                                                                                                                                    |
| D10_D11_P | 48                    | O   | Differential output data D10 and D11 multiplexed, true                                                                                                                                        |
| D10_D11_M | 47                    | O   | Differential output data D10 and D11 multiplexed, complement                                                                                                                                  |
| DFS       | 6                     | I   | Data format select input. This pin sets the DATA FORMAT (twos complement or offset binary) and the LVDS and CMOS output interface type. See <a href="#">Table 9</a> for detailed information. |
| DRGND     | 1, 36, PAD            | I   | Digital and output buffer ground                                                                                                                                                              |

### Pin Functions - LVDS Mode (continued)

| PIN       |                    | I/O | DESCRIPTION                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
|-----------|--------------------|-----|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME      | NO.                |     |                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| DRVDD     | 2, 35              | I   | 1.8-V digital and output buffer supply                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| INM       | 16                 | I   | Differential analog input, negative                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| INP       | 15                 | I   | Differential analog input, positive                                                                                                                                                                                                                                                                                                                                                                                                                                          |
| NC        | 21, 31, 32, 33, 34 | —   | Do not connect                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
| OE        | 7                  | I   | Output buffer enable input, active high; this pin has an internal 180-kΩ pull-up resistor to DRVDD.                                                                                                                                                                                                                                                                                                                                                                          |
| OVR_SDOUT | 3                  | O   | This pin functions as an out-of-range indicator after reset when register bit READOUT = 0, and functions as a serial register readout pin when READOUT = 1.                                                                                                                                                                                                                                                                                                                  |
| RESERVED  | 23                 | I   | Digital control pin, reserved for future use                                                                                                                                                                                                                                                                                                                                                                                                                                 |
| RESET     | 30                 | I   | Serial interface RESET input.<br>When using the serial interface mode, the internal registers must initialize through hardware RESET by applying a high pulse on this pin or by using the software reset option; refer to the <a href="#">Serial Interface</a> section.<br>When RESET is tied high, the internal registers are reset to the default values. In this condition, SEN can be used as an analog control pin.<br>RESET has an internal 180-kΩ pull-down resistor. |
| SCLK      | 29                 | I   | This pin functions as a serial interface clock input when RESET is low. When RESET is high, SCLK has no function and should be tied to ground.<br>This pin has an internal 180-kΩ pull-down resistor.                                                                                                                                                                                                                                                                        |
| SDATA     | 28                 | I   | This pin functions as a serial interface data input when RESET is low. When RESET is high, SDATA functions as a STANDBY control pin (see <a href="#">Table 11</a> ).<br>This pin has an internal 180-kΩ pull-down resistor.                                                                                                                                                                                                                                                  |
| SEN       | 27                 | I   | This pin functions as a serial interface enable input when RESET is low. When RESET is high, SEN has no function and should be tied to AVDD.<br>This pin has an internal 180-kΩ pull-up resistor to AVDD.                                                                                                                                                                                                                                                                    |
| VCM       | 13                 | O   | Outputs the common-mode voltage (0.95 V) that can be used externally to bias the analog input pins.                                                                                                                                                                                                                                                                                                                                                                          |

**RGZ Package<sup>(2)</sup>**  
**48-Pin VQFN With Exposed Thermal Pad**  
**CMOS - Top View**



The thermal pad is connected to DRGND.

## Pin Functions - CMOS Mode

| PIN       |                       | I/O | DESCRIPTION                                                                                                                                                                                                                                                                                                                                                                                                                                                                          |
|-----------|-----------------------|-----|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME      | NO.                   |     |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |
| AGND      | 9, 12, 14, 17, 19, 25 | I   | Analog ground                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
| AVDD      | 8, 18, 20, 22, 24, 26 | I   | 1.8-V analog power supply                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| CLKM      | 11                    | I   | Differential clock input, negative                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| CLKP      | 10                    | I   | Differential clock input, positive                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| CLKOUT    | 5                     | O   | CMOS output clock                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |
| D0        | 37                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D1        | 38                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D2        | 39                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D3        | 40                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D4        | 41                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D5        | 42                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D6        | 43                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D7        | 44                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D8        | 45                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D9        | 46                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D10       | 47                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| D11       | 48                    | O   | 12-bit CMOS output data                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| DFS       | 6                     | I   | Data format select input. This pin sets the DATA FORMAT (twos complement or offset binary) and the LVDS and CMOS output interface type. See <a href="#">Table 9</a> for detailed information.                                                                                                                                                                                                                                                                                        |
| DRGND     | 1, 36, PAD            | I   | Digital and output buffer ground                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| DRVDD     | 2, 35                 | I   | 1.8-V digital and output buffer supply                                                                                                                                                                                                                                                                                                                                                                                                                                               |
| INP       | 15                    | I   | Differential analog input, positive                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| INM       | 16                    | I   | Differential analog input, negative                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| NC        | 21, 31, 32, 33, 34    | —   | Do not connect                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| OE        | 7                     | I   | Output buffer enable input, active high; this pin has an internal 180-k $\Omega$ pull-up resistor to DRVDD.                                                                                                                                                                                                                                                                                                                                                                          |
| OVR_SDOUT | 3                     | O   | This pin functions as an out-of-range indicator after reset when register bit READOUT = 0, and functions as a serial register readout pin when READOUT = 1.                                                                                                                                                                                                                                                                                                                          |
| RESET     | 30                    | I   | Serial interface RESET input.<br>When using the serial interface mode, the internal registers must initialize through hardware RESET by applying a high pulse on this pin or by using the software reset option; refer to the <a href="#">Serial Interface</a> section.<br>When RESET is tied high, the internal registers are reset to the default values. In this condition, SEN can be used as an analog control pin.<br>RESET has an internal 180-k $\Omega$ pull-down resistor. |
| RESERVED  | 23                    | I   | Digital control pin, reserved for future use                                                                                                                                                                                                                                                                                                                                                                                                                                         |
| SCLK      | 29                    | I   | This pin functions as a serial interface clock input when RESET is low. When RESET is high, SCLK has no function and should be tied to ground.<br>This pin has an internal 180-k $\Omega$ pull-down resistor.                                                                                                                                                                                                                                                                        |
| SDATA     | 28                    | I   | This pin functions as a serial interface data input when RESET is low. When RESET is high, SDATA functions as a STANDBY control pin (see <a href="#">Table 11</a> ).<br>This pin has an internal 180-k $\Omega$ pull-down resistor.                                                                                                                                                                                                                                                  |
| SEN       | 27                    | I   | This pin functions as a serial interface enable input when RESET is low. When RESET is high, SEN has no function and should be tied to AVDD.<br>This pin has an internal 180-k $\Omega$ pull-up resistor to AVDD.                                                                                                                                                                                                                                                                    |
| UNUSED    | 4                     | —   | Unused pin in CMOS mode                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| VCM       | 13                    | O   | Outputs the common-mode voltage (0.95 V) that can be used externally to bias the analog input pins.                                                                                                                                                                                                                                                                                                                                                                                  |

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                               |                                               | MIN  | MAX              | UNIT |
|-------------------------------|-----------------------------------------------|------|------------------|------|
| Supply voltage                | AVDD                                          | −0.3 | 2.1              | V    |
|                               | DRVDD                                         | −0.3 | 2.1              |      |
| Voltage                       | Between AGND and DRGND                        | −0.3 | 0.3              | V    |
|                               | Between AVDD to DRVDD (when AVDD leads DRVDD) | 0    | 2.1              |      |
|                               | Between DRVDD to AVDD (when DRVDD leads AVDD) | 0    | 2.1              |      |
| Voltage applied to input pins | INP, INM                                      | −0.3 | (1.9) AVDD + 0.3 | V    |
|                               | CLKP, CLKM <sup>(2)</sup> , DFS, OE           | −0.3 | AVDD + 0.3       |      |
|                               | RESET, SCLK, SDATA, SEN                       | −0.3 | 3.9              |      |
| Temperature                   | Operating free-air, T <sub>A</sub>            | −40  | 85               | °C   |
|                               | Operating junction, T <sub>J</sub>            |      | 125              |      |
|                               | Storage, T <sub>stg</sub>                     | −65  | 150              | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) When AVDD is turned off, it is recommended to switch off the input clock (or ensure the voltage on CLKP and CLKM is less than |0.3 V|. This setting prevents the ESD protection diodes at the clock input pins from turning on.

### 7.2 ESD Ratings

|                                            |                                                                                | VALUE | UNIT |
|--------------------------------------------|--------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±1000 | V    |
|                                            | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±500  |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

Over operating free-air temperature range, unless otherwise noted.

|                                                                             |                                                       | MIN                    | TYP | MAX | UNIT            |
|-----------------------------------------------------------------------------|-------------------------------------------------------|------------------------|-----|-----|-----------------|
| SUPPLIES                                                                    |                                                       |                        |     |     |                 |
| AVDD                                                                        | Analog supply voltage                                 | 1.7                    | 1.8 | 1.9 | V               |
| DRVDD                                                                       | Digital supply voltage                                | 1.7                    | 1.8 | 1.9 |                 |
| ANALOG INPUTS                                                               |                                                       |                        |     |     |                 |
| Differential input voltage range <sup>(1)</sup>                             |                                                       | 2                      |     |     | V <sub>PP</sub> |
| Input common-mode voltage                                                   |                                                       | V <sub>CM</sub> ± 0.05 |     |     | V               |
| Maximum analog input frequency                                              | With 2-V <sub>PP</sub> input amplitude <sup>(2)</sup> | 400                    |     |     | MHz             |
|                                                                             | With 1-V <sub>PP</sub> input amplitude <sup>(2)</sup> | 800                    |     |     |                 |
| CLOCK INPUT                                                                 |                                                       |                        |     |     |                 |
| Input clock sample rate, low-speed mode                                     | Enabled <sup>(3)</sup>                                | 20                     |     | 80  | MSPS            |
|                                                                             | Disabled <sup>(3)</sup>                               | > 80                   |     | 200 |                 |
| Input clock amplitude differential (V <sub>CLKP</sub> – V <sub>CLKM</sub> ) | Sine wave, ac-coupled                                 | 0.2                    | 1.5 |     | V <sub>PP</sub> |
|                                                                             | LVPECL, ac-coupled                                    |                        | 1.6 |     |                 |
|                                                                             | LVDS, ac-coupled                                      |                        | 0.7 |     |                 |
|                                                                             | LVC MOS, single-ended, ac-coupled                     |                        | 1.8 |     | V               |

- (1) With 0-dB gain. See the [Fine Gain](#) section in the [Detailed Description](#) for relation between input voltage range and gain.
- (2) See the [Overview](#) section in the [Detailed Description](#).
- (3) See the [Serial Interface](#) section for details on low-speed mode.

## Recommended Operating Conditions (continued)

Over operating free-air temperature range, unless otherwise noted.

|                        |                                                                        | MIN | TYP | MAX | UNIT |
|------------------------|------------------------------------------------------------------------|-----|-----|-----|------|
| Input clock duty cycle | Low-speed mode enabled                                                 | 40% | 50% | 60% |      |
|                        | Low-speed mode disabled                                                | 35% | 50% | 65% |      |
| <b>DIGITAL OUTPUTS</b> |                                                                        |     |     |     |      |
| C <sub>LOAD</sub>      | Maximum external load capacitance from each output pin to DRGND        | 5   |     |     | pF   |
| R <sub>LOAD</sub>      | Differential load resistance between the LVDS output pairs (LVDS mode) | 100 |     |     | Ω    |
| T <sub>A</sub>         | Operating free-air temperature                                         | –40 |     | 85  | °C   |

## 7.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | ADS4128    | UNIT |
|-------------------------------|----------------------------------------------|------------|------|
|                               |                                              | RGZ (VQFN) |      |
|                               |                                              | 48 PINS    |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 27.9       | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 15.1       | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 5.4        | °C/W |
| ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 0.3        | °C/W |
| ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 5.4        | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | 1.7        | °C/W |

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 7.5 Electrical Characteristics

Typical values are at 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, 50% clock duty cycle, –1-dBFS differential analog input, 1-dB gain, and DDR LVDS interface, unless otherwise noted.

Minimum and maximum values are across the full temperature range: T<sub>MIN</sub> = –40°C to T<sub>MAX</sub> = 85°C, AVDD = 1.8 V, and DRVDD = 1.8 V. Note that after reset, the device is in 0-dB gain mode.

| PARAMETER               |                                                       | TEST CONDITIONS                                                                  | MIN   | TYP  | MAX | UNIT         |
|-------------------------|-------------------------------------------------------|----------------------------------------------------------------------------------|-------|------|-----|--------------|
| Resolution              |                                                       |                                                                                  |       |      | 12  | Bits         |
| SNR                     | Signal-to-noise ratio, LVDS                           | f <sub>IN</sub> = 10 MHz                                                         |       | 70   |     | dBFS         |
|                         |                                                       | f <sub>IN</sub> = 70 MHz                                                         |       | 70   |     |              |
|                         |                                                       | f <sub>IN</sub> = 100 MHz                                                        |       | 69.7 |     |              |
|                         |                                                       | f <sub>IN</sub> = 170 MHz                                                        | 65.8  | 69   |     |              |
|                         |                                                       | f <sub>IN</sub> = 300 MHz                                                        |       | 68.2 |     |              |
| SINAD                   | Signal-to-noise and distortion ratio, LVDS            | f <sub>IN</sub> = 10 MHz                                                         |       | 69.8 |     | dBFS         |
|                         |                                                       | f <sub>IN</sub> = 70 MHz                                                         |       | 69.2 |     |              |
|                         |                                                       | f <sub>IN</sub> = 100 MHz                                                        |       | 69.1 |     |              |
|                         |                                                       | f <sub>IN</sub> = 170 MHz                                                        | 65.5  | 68.8 |     |              |
|                         |                                                       | f <sub>IN</sub> = 300 MHz                                                        |       | 67   |     |              |
| SFDR                    | Spurious-free dynamic range                           | f <sub>IN</sub> = 10 MHz                                                         |       | 87   |     | dBc          |
|                         |                                                       | f <sub>IN</sub> = 70 MHz                                                         |       | 80   |     |              |
|                         |                                                       | f <sub>IN</sub> = 100 MHz                                                        |       | 82   |     |              |
|                         |                                                       | f <sub>IN</sub> = 170 MHz                                                        | 70    | 85   |     |              |
|                         |                                                       | f <sub>IN</sub> = 300 MHz                                                        |       | 74   |     |              |
| THD                     | Total harmonic distortion                             | f <sub>IN</sub> = 10 MHz                                                         |       | 84   |     | dBc          |
|                         |                                                       | f <sub>IN</sub> = 70 MHz                                                         |       | 78   |     |              |
|                         |                                                       | f <sub>IN</sub> = 100 MHz                                                        |       | 79   |     |              |
|                         |                                                       | f <sub>IN</sub> = 170 MHz                                                        | 69    | 83   |     |              |
|                         |                                                       | f <sub>IN</sub> = 300 MHz                                                        |       | 73   |     |              |
| HD2                     | Second-harmonic distortion                            | f <sub>IN</sub> = 10 MHz                                                         |       | 90   |     | dBc          |
|                         |                                                       | f <sub>IN</sub> = 70 MHz                                                         |       | 84   |     |              |
|                         |                                                       | f <sub>IN</sub> = 100 MHz                                                        |       | 83   |     |              |
|                         |                                                       | f <sub>IN</sub> = 170 MHz                                                        | 70    | 85   |     |              |
|                         |                                                       | f <sub>IN</sub> = 300 MHz                                                        |       | 74   |     |              |
| HD3                     | Third-harmonic distortion                             | f <sub>IN</sub> = 10 MHz                                                         |       | 87   |     | dBc          |
|                         |                                                       | f <sub>IN</sub> = 70 MHz                                                         |       | 80   |     |              |
|                         |                                                       | f <sub>IN</sub> = 100 MHz                                                        |       | 82   |     |              |
|                         |                                                       | f <sub>IN</sub> = 170 MHz                                                        | 70    | 86   |     |              |
|                         |                                                       | f <sub>IN</sub> = 300 MHz                                                        |       | 79   |     |              |
|                         | Worst spur<br>(other than second and third harmonics) | f <sub>IN</sub> = 10 MHz                                                         |       | 93   |     | dBc          |
|                         |                                                       | f <sub>IN</sub> = 70 MHz                                                         |       | 93   |     |              |
|                         |                                                       | f <sub>IN</sub> = 100 MHz                                                        |       | 91   |     |              |
|                         |                                                       | f <sub>IN</sub> = 170 MHz                                                        | 75    | 90   |     |              |
|                         |                                                       | f <sub>IN</sub> = 300 MHz                                                        |       | 88   |     |              |
| IMD                     | Two-tone intermodulation distortion                   | f <sub>1</sub> = 46 MHz, f <sub>2</sub> = 50 MHz,<br>each tone at –7 dBFS        |       | –85  |     | dBFS         |
|                         |                                                       | f <sub>1</sub> = 185 MHz, f <sub>2</sub> = 190 MHz,<br>each tone at –7 dBFS      |       | –90  |     |              |
| Input overload recovery |                                                       | Recovery to within 1% (of final value) for<br>6-dB overload with sine-wave input |       | 1    |     | Clock cycles |
| PSRR                    | AC power-supply rejection ratio                       | For 50-mV <sub>PP</sub> signal on AVDD supply,<br>up to 10 MHz                   |       | > 30 |     | dB           |
| ENOB                    | Effective number of bits                              | f <sub>IN</sub> = 170 MHz                                                        |       | 11.2 |     | LSBs         |
| DNL                     | Differential nonlinearity                             | f <sub>IN</sub> = 170 MHz                                                        | –0.95 | ±0.2 | 1.6 | LSBs         |
| INL                     | Integrated nonlinearity                               | f <sub>IN</sub> = 170 MHz                                                        |       | ±0.5 | ±5  | LSBs         |

## 7.6 Electrical Characteristics: General

Typical values are at 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, 50% clock duty cycle, and 0-dB gain, unless otherwise noted. Minimum and maximum values are across the full temperature range: T<sub>MIN</sub> = –40°C to T<sub>MAX</sub> = 85°C, AVDD = 1.8 V, and DRVDD = 1.8 V.

| PARAMETER             |                                                                              | TEST CONDITIONS                                             | MIN | TYP   | MAX | UNIT            |
|-----------------------|------------------------------------------------------------------------------|-------------------------------------------------------------|-----|-------|-----|-----------------|
| <b>ANALOG INPUTS</b>  |                                                                              |                                                             |     |       |     |                 |
|                       | Differential input voltage range                                             |                                                             |     | 2     |     | V <sub>PP</sub> |
|                       | Differential input resistance (at dc); see <a href="#">Figure 47</a>         |                                                             |     | > 1   |     | MΩ              |
|                       | Differential input capacitance; see <a href="#">Figure 48</a>                |                                                             |     | 4     |     | pF              |
|                       | Analog input bandwidth                                                       |                                                             |     | 550   |     | MHz             |
|                       | Analog input common-mode current (per input pin)                             |                                                             |     | 0.6   |     | μA/MSPS         |
| VCM                   | Common-mode output voltage                                                   |                                                             |     | 0.95  |     | V               |
|                       | VCM output current capability                                                |                                                             |     | 4     |     | mA              |
| <b>DC ACCURACY</b>    |                                                                              |                                                             |     |       |     |                 |
|                       | Offset error                                                                 |                                                             | –15 | 2.5   | 15  | mV              |
|                       | Temperature coefficient of offset error                                      |                                                             |     | 0.003 |     | mV/°C           |
| E <sub>GREF</sub>     | Gain error as a result of internal reference inaccuracy alone                |                                                             | –2  |       | 2   | %FS             |
| E <sub>GCHAN</sub>    | Gain error of channel alone                                                  |                                                             |     | –0.2  | ±1  | %FS             |
|                       | Temperature coefficient of E <sub>GCHAN</sub>                                |                                                             |     | 0.001 |     | Δ%/°C           |
| <b>POWER SUPPLY</b>   |                                                                              |                                                             |     |       |     |                 |
| IAVDD                 | Analog supply current                                                        |                                                             |     | 85    | 113 | mA              |
| IDRVDD <sup>(1)</sup> | Output buffer supply current, LVDS interface with 100-Ω external termination | Low LVDS swing (200 mV)                                     |     | 43    |     | mA              |
|                       |                                                                              | Standard LVDS swing (350 mV)                                |     | 55    | 72  |                 |
|                       | Output buffer supply current <sup>(1)(2)</sup> CMOS interface                | 8-pF external load capacitance<br>f <sub>IN</sub> = 2.5 MHz |     | 33    |     |                 |
|                       | Analog power                                                                 |                                                             |     | 153   |     | mW              |
|                       | Digital power, LVDS interface                                                | Low LVDS swing (200 mV)                                     |     | 77    |     | mW              |
|                       | Digital power, CMOS interface <sup>(2)</sup>                                 | 8-pF external load capacitance<br>f <sub>IN</sub> = 2.5 MHz |     | 59    |     | mW              |
|                       | Global power-down                                                            |                                                             |     | 10    | 25  | mW              |
|                       | Standby                                                                      |                                                             |     | 185   |     | mW              |

- (1) The maximum DRVDD current with CMOS interface depends on the actual load capacitance on the digital output lines. Note that the maximum recommended load capacitance on each digital output line is 10 pF.
- (2) In CMOS mode, the DRVDD current scales with the sampling frequency, the load capacitance on the output pins, input frequency, and the supply voltage (see the [CMOS Interface Power Dissipation](#) section in the [Device Functional Modes](#)).

## 7.7 Digital Characteristics

Typical values are at 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, and 50% clock duty cycle, unless otherwise noted.

Minimum and maximum values are across the full temperature range: T<sub>MIN</sub> = –40°C to T<sub>MAX</sub> = 85°C, AVDD = 1.8 V, and DRVDD = 1.8 V.

| PARAMETER                                                                                                                 |                                                         | TEST CONDITIONS                                                       | MIN         | TYP   | MAX  | UNIT |
|---------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------|-----------------------------------------------------------------------|-------------|-------|------|------|
| DIGITAL INPUTS (RESET, SCLK, SDATA, SEN, OE)                                                                              |                                                         |                                                                       |             |       |      |      |
| V <sub>IH</sub> High-level input voltage                                                                                  |                                                         | RESET, SCLK, SDATA, and SEN support 1.8-V and 3.3-V CMOS logic levels | 1.3         |       |      | V    |
|                                                                                                                           |                                                         | OE only supports 1.8-V CMOS logic levels                              | 1.3         |       |      |      |
| V <sub>IL</sub> Low-level input voltage                                                                                   |                                                         | RESET, SCLK, SDATA, and SEN support 1.8-V and 3.3-V CMOS logic levels |             |       | 0.4  | V    |
|                                                                                                                           |                                                         | OE only supports 1.8-V CMOS logic levels                              |             |       | 0.4  |      |
| I <sub>IH</sub>                                                                                                           | High-level input current, SDATA and SCLK <sup>(1)</sup> | V <sub>HIGH</sub> = 1.8 V                                             |             | 10    |      | μA   |
|                                                                                                                           | High-level input current, SEN                           | V <sub>HIGH</sub> = 1.8 V                                             |             | 0     |      |      |
| I <sub>IL</sub>                                                                                                           | Low-level input, SDATA and SCLK                         | V <sub>LOW</sub> = 0 V                                                |             | 0     |      | μA   |
|                                                                                                                           | Low-level input, SEN                                    | V <sub>LOW</sub> = 0 V                                                |             | 10    |      |      |
| DIGITAL OUTPUTS (CMOS INTERFACE: D0 to D11, OVR_SDOUT)                                                                    |                                                         |                                                                       |             |       |      |      |
| V <sub>OH</sub>                                                                                                           | High-level output voltage                               |                                                                       | DRVDD – 0.1 | DRVDD |      | V    |
| V <sub>OL</sub>                                                                                                           | Low-level output voltage                                |                                                                       |             | 0     | 0.1  | V    |
| DIGITAL OUTPUTS (LVDS INTERFACE: DA0P and DA0M to DA11P and DA11M, DB0P and DB0M to DB11P and DB11M, CLKOUTP and CLKOUTM) |                                                         |                                                                       |             |       |      |      |
| V <sub>ODH</sub> High-level output voltage <sup>(2)</sup>                                                                 |                                                         | Standard-swing LVDS                                                   | 270         | 350   | 430  | mV   |
|                                                                                                                           |                                                         | Low-swing LVDS                                                        |             | 200   |      |      |
| V <sub>ODL</sub> Low-level output voltage <sup>(2)</sup>                                                                  |                                                         | Standard-swing LVDS                                                   | –430        | –350  | –270 | mV   |
|                                                                                                                           |                                                         | Low-swing LVDS                                                        |             | –200  |      |      |
| V <sub>OCM</sub> Output common-mode voltage                                                                               |                                                         |                                                                       | 0.85        | 1.05  | 1.25 | V    |

(1) SDATA and SCLK have an internal 180-kΩ pull-down resistor.

(2) With an external 100-Ω termination.

## 7.8 Timing Requirements: LVDS and CMOS Modes<sup>(1)</sup>

Typical values are at 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, sampling frequency = 200 MSPS, sine wave input clock, C<sub>LOAD</sub> = 5 pF<sup>(2)</sup>, and R<sub>LOAD</sub> = 100 Ω<sup>(3)</sup>, unless otherwise noted. Minimum and maximum values are across the full temperature range: T<sub>MIN</sub> = –40°C to T<sub>MAX</sub> = 85°C, AVDD = 1.8 V, and DRVDD = 1.7 V to 1.9 V.

|                                             |                                                     |                                                                                                                                       | MIN  | NOM  | MAX | UNIT               |    |
|---------------------------------------------|-----------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------|------|------|-----|--------------------|----|
| t <sub>A</sub>                              | Aperture delay                                      |                                                                                                                                       | 0.6  | 0.8  | 1.2 | ns                 |    |
|                                             | Aperture delay variation                            | Between two devices at the same temperature and DRVDD supply                                                                          | ±100 |      |     | ps                 |    |
| t <sub>J</sub>                              | Aperture jitter                                     |                                                                                                                                       | 100  |      |     | f <sub>S</sub> rms |    |
|                                             | Wakeup time                                         | Time to valid data after coming out of STANDBY mode                                                                                   | 5    | 25   |     | μs                 |    |
|                                             |                                                     | Time to valid data after coming out of PDN GLOBAL mode                                                                                | 100  | 500  |     |                    |    |
| ADC latency <sup>(4)</sup>                  |                                                     | Low-latency mode (default after reset)                                                                                                | 10   |      |     | Clock cycles       |    |
|                                             |                                                     | Low-latency mode disabled (gain enabled, offset correction disabled)                                                                  | 16   |      |     |                    |    |
|                                             |                                                     | Low-latency mode disabled (gain and offset correction enabled)                                                                        | 17   |      |     |                    |    |
| DDR LVDS MODE <sup>(5)(6)</sup>             |                                                     |                                                                                                                                       |      |      |     |                    |    |
| t <sub>SU</sub>                             | Data setup time <sup>(3)</sup>                      | Data valid <sup>(7)</sup> to zero-crossing of CLKOUTP                                                                                 | 1.05 | 1.55 |     | ns                 |    |
| t <sub>H</sub>                              | Data hold time <sup>(3)</sup>                       | Zero-crossing of CLKOUTP to data becoming invalid <sup>(7)</sup>                                                                      | 0.35 | 0.6  |     | ns                 |    |
| t <sub>PDI</sub>                            | Clock propagation delay                             | Input clock rising edge crossover to output clock rising edge crossover<br>1 MSPS ≤ sampling frequency ≤ 200 MSPS                     | 3    | 4.2  | 5.4 | ns                 |    |
|                                             | Variation of t <sub>PDI</sub>                       | Between two devices at the same temperature and DRVDD supply                                                                          | ±0.6 |      |     | ns                 |    |
|                                             | LVDS bit clock duty cycle                           | Duty cycle of differential clock, (CLKOUTP – CLKOUTM)<br>1 MSPS ≤ sampling frequency ≤ 200 MSPS                                       | 42%  | 48%  | 54% |                    |    |
| t <sub>RISE</sub> , t <sub>FALL</sub>       | Data rising time, Data falling time                 | Rising time measured from –100 mV to 100 mV<br>Falling time measured from 100 mV to –100 mV<br>1 MSPS ≤ sampling frequency ≤ 200 MSPS | 0.14 |      |     | ns                 |    |
| t <sub>CLKRISE</sub> , t <sub>CLKFALL</sub> | Output clock rising time, Output clock falling time | Rising time measured from –100 mV to 100 mV<br>Falling time measured from 100 mV to –100 mV<br>1 MSPS ≤ sampling frequency ≤ 200 MSPS | 0.14 |      |     | ns                 |    |
| t <sub>OE</sub>                             | Output enable (OE) to data delay                    | Time to valid data after OE becomes active                                                                                            | 50   |      |     | 100                | ns |
| PARALLEL CMOS MODE <sup>(8)</sup>           |                                                     |                                                                                                                                       |      |      |     |                    |    |
| t <sub>START</sub>                          | Input clock to data delay                           | Input clock rising edge crossover to start of data valid <sup>(7)</sup>                                                               | –0.3 |      |     | ns                 |    |
| t <sub>DV</sub>                             | Data valid time                                     | Time interval of valid data <sup>(7)</sup>                                                                                            | 3.5  | 4.2  |     | ns                 |    |
| t <sub>PDI</sub>                            | Clock propagation delay                             | Input clock rising edge crossover to output clock rising edge crossover<br>1 MSPS ≤ sampling frequency ≤ 200 MSPS                     | 4    | 5.5  | 7   | ns                 |    |
|                                             | Output clock duty cycle                             | Duty cycle of output clock, CLKOUT<br>1 MSPS ≤ sampling frequency ≤ 200 MSPS                                                          | 47%  |      |     |                    |    |
| t <sub>RISE</sub> , t <sub>FALL</sub>       | Data rising time, Data falling time                 | Rising time measured from 20% to 80% of DRVDD<br>Falling time measured from 80% to 20% of DRVDD<br>1 ≤ sampling frequency ≤ 200 MSPS  | 0.35 |      |     | ns                 |    |
| t <sub>CLKRISE</sub> , t <sub>CLKFALL</sub> | Output clock rising time, Output clock falling time | Rising time measured from 20% to 80% of DRVDD<br>Falling time measured from 80% to 20% of DRVDD<br>1 ≤ sampling frequency ≤ 200 MSPS  | 0.35 |      |     | ns                 |    |
| t <sub>OE</sub>                             | Output enable (OE) to data delay                    | Time to valid data after OE becomes active                                                                                            | 20   |      |     | 40                 | ns |

(1) Timing parameters are ensured by design and characterization but are not production tested.

(2) C<sub>LOAD</sub> is the effective external single-ended load capacitance between each output pin and ground.

(3) R<sub>LOAD</sub> is the differential load resistance between the LVDS output pair.

(4) At higher frequencies, t<sub>PDI</sub> is greater than one clock period and overall latency = ADC latency + 1.

(5) Measurements are done with a transmission line of 100-Ω characteristic impedance between the device and the load. Setup and hold time specifications take into account the effect of jitter on the output data and clock.

(6) The LVDS timings are unchanged for low latency disabled and enabled.

(7) Data valid refers to a logic high of 1.26 V and a logic low of 0.54 V.

(8) Low-latency mode enabled.

## 7.9 Reset Timing Requirements

Typical values are at 25°C and minimum and maximum values are across the full temperature range:  $T_{MIN} = -40^{\circ}\text{C}$  to  $T_{MAX} = 85^{\circ}\text{C}$ , unless otherwise noted.

|       |                   |                                                                     | MIN | TYP | MAX              | UNIT |
|-------|-------------------|---------------------------------------------------------------------|-----|-----|------------------|------|
| $t_1$ | Power-on delay    | Delay from power-up of AVDD and DRVDD to RESET pulse active         | 1   |     |                  | ms   |
| $t_2$ | Reset pulse width | Pulse width of active RESET signal that resets the serial registers | 10  |     |                  | ns   |
|       |                   |                                                                     |     |     | 1 <sup>(1)</sup> | μs   |
| $t_3$ |                   | Delay from RESET disable to SEN active                              | 100 |     |                  | ns   |

- (1) The reset pulse is needed only when using the serial interface configuration. If the pulse width is greater than 1 μs, the device can enter the parallel configuration mode briefly and then return back to serial interface mode.

**Table 1. LVDS Timing Across Sampling Frequencies**

| SAMPLING<br>FREQUENCY<br>(MSPS) | SETUP TIME (ns) |      |     | HOLD TIME (ns) |     |     |
|---------------------------------|-----------------|------|-----|----------------|-----|-----|
|                                 | MIN             | TYP  | MAX | MIN            | TYP | MAX |
| 200                             | 1.05            | 1.55 | —   | 0.35           | 0.6 | —   |
| 185                             | 1.1             | 1.7  | —   | 0.35           | 0.6 | —   |
| 160                             | 1.6             | 2.1  | —   | 0.35           | 0.6 | —   |
| 125                             | 2.3             | 3    | —   | 0.35           | 0.6 | —   |
| 80                              | 4.5             | 5.2  | —   | 0.35           | 0.6 | —   |

**Table 2. CMOS Timing Across Sampling Frequencies (Low Latency Enabled)**

| SAMPLING<br>FREQUENCY<br>(MSPS) | TIMING SPECIFIED WITH RESPECT TO OUTPUT CLOCK |     |     |                 |     |     |                |     |     |
|---------------------------------|-----------------------------------------------|-----|-----|-----------------|-----|-----|----------------|-----|-----|
|                                 | $t_{SETUP}$ (ns)                              |     |     | $t_{HOLD}$ (ns) |     |     | $t_{PDI}$ (ns) |     |     |
|                                 | MIN                                           | TYP | MAX | MIN             | TYP | MAX | MIN            | TYP | MAX |
| 200                             | 1.6                                           | 2.2 | —   | 1.8             | 2.5 | —   | 4              | 5.5 | 7   |
| 185                             | 1.8                                           | 2.4 | —   | 1.9             | 2.7 | —   | 4              | 5.5 | 7   |
| 160                             | 2.3                                           | 2.9 | —   | 2.2             | 3   | —   | 4              | 5.5 | 7   |
| 125                             | 3.1                                           | 3.7 | —   | 3.2             | 4   | —   | 4              | 5.5 | 7   |
| 80                              | 5.4                                           | 6   | —   | 5.4             | 6   | —   | 4              | 5.5 | 7   |

**Table 3. CMOS Timing Across Sampling Frequencies (Low Latency Disabled)**

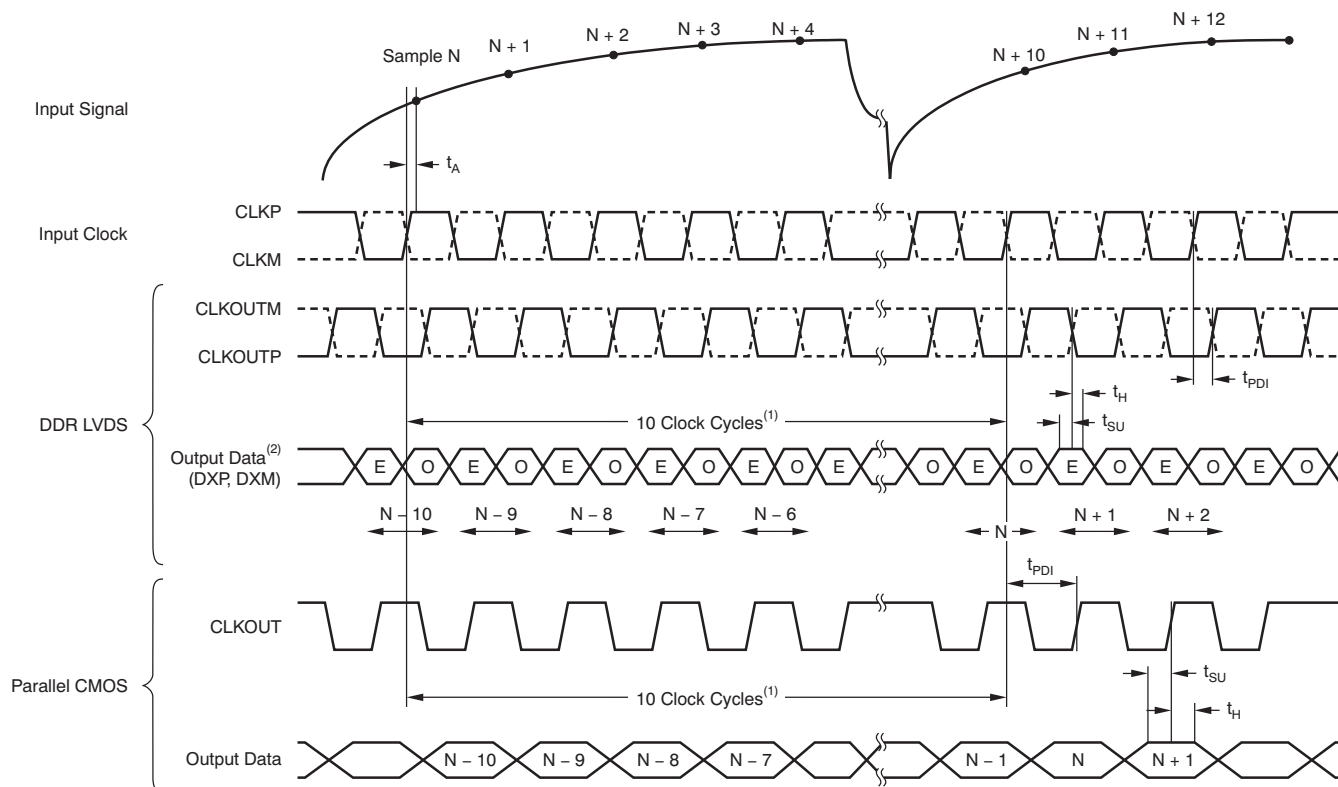
| SAMPLING<br>FREQUENCY<br>(MSPS) | TIMING SPECIFIED WITH RESPECT TO OUTPUT CLOCK |     |     |                 |     |     |                |     |     |
|---------------------------------|-----------------------------------------------|-----|-----|-----------------|-----|-----|----------------|-----|-----|
|                                 | $t_{SETUP}$ (ns)                              |     |     | $t_{HOLD}$ (ns) |     |     | $t_{PDI}$ (ns) |     |     |
|                                 | MIN                                           | TYP | MAX | MIN             | TYP | MAX | MIN            | TYP | MAX |
| 200                             | 1                                             | 1.6 | —   | 2               | 2.8 | —   | 4              | 5.5 | 7   |
| 185                             | 1.3                                           | 2   | —   | 2.2             | 3   | —   | 4              | 5.5 | 7   |
| 160                             | 1.8                                           | 2.5 | —   | 2.5             | 3.3 | —   | 4              | 5.5 | 7   |
| 125                             | 2.5                                           | 3.2 | —   | 3.5             | 4.3 | —   | 4              | 5.5 | 7   |
| 80                              | 4.8                                           | 5.5 | —   | 5.7             | 6.5 | —   | 4              | 5.5 | 7   |

**Table 4. CMOS Timing Across Sampling Frequencies (Low Latency Enabled)**

| SAMPLING FREQUENCY<br>(MSPS) | TIMING SPECIFIED WITH RESPECT TO INPUT CLOCK |     |      |               |     |     |  |
|------------------------------|----------------------------------------------|-----|------|---------------|-----|-----|--|
|                              | $t_{START}$ (ns)                             |     |      | $t_{DV}$ (ns) |     |     |  |
|                              | MIN                                          | TYP | MAX  | MIN           | TYP | MAX |  |
| 200                          | —                                            | —   | –0.3 | 3.5           | 4.2 | —   |  |
| 185                          | —                                            | —   | –1   | 3.9           | 4.5 | —   |  |
| 170                          | —                                            | —   | –1.5 | 4.3           | 5   | —   |  |

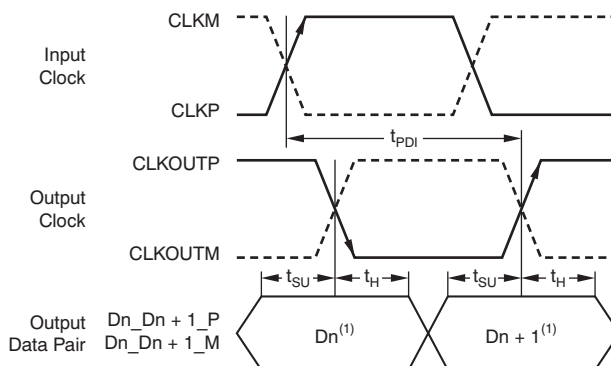
**Table 5. CMOS Timing Across Sampling Frequencies (Low Latency Disabled)**

| SAMPLING FREQUENCY<br>(MSPS) | TIMING SPECIFIED WITH RESPECT TO INPUT CLOCK |     |      |                      |     |     |
|------------------------------|----------------------------------------------|-----|------|----------------------|-----|-----|
|                              | $t_{\text{START}}$ (ns)                      |     |      | $t_{\text{DV}}$ (ns) |     |     |
|                              | MIN                                          | TYP | MAX  | MIN                  | TYP | MAX |
| 200                          | —                                            | —   | 0.3  | 3.5                  | 4.2 | —   |
| 185                          | —                                            | —   | 0    | 3.9                  | 4.5 | —   |
| 170                          | —                                            | —   | -1.3 | 4.3                  | 5   | —   |



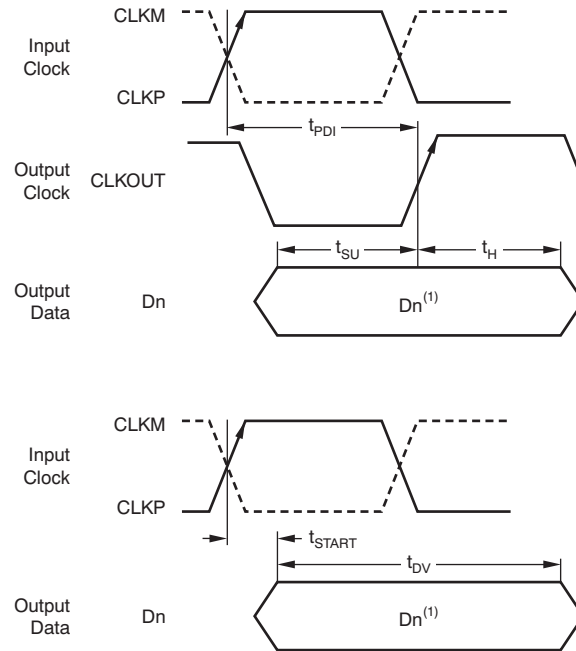
ADC latency in low-latency mode. At higher sampling frequencies,  $t_{\text{DPI}}$  is greater than one clock cycle which then makes the overall latency = ADC latency + 1.

E = Even bits (D0, D2, D4, and so on). O = Odd bits (D1, D3, D5, and so on).

**Figure 1. Latency Diagram**

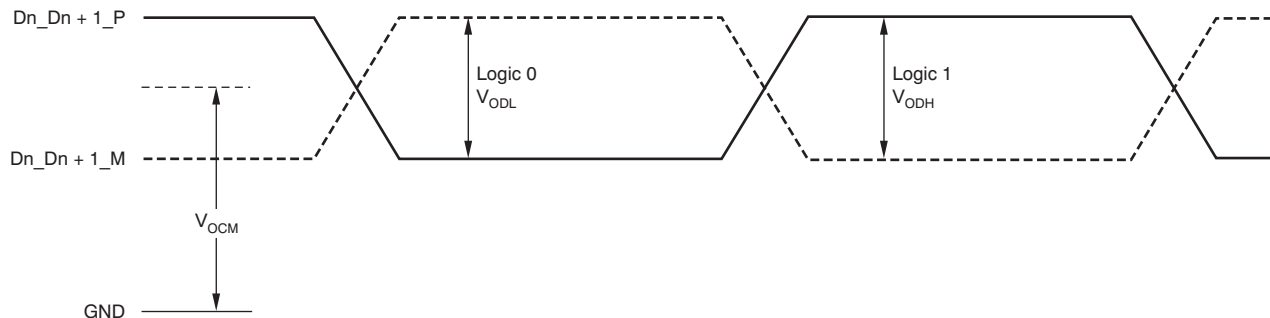
$D_n$  = bits D0, D2, D4, and so on.  $D_n + 1$  = bits D1, D3, D5, and so on.

**Figure 2. LVDS Mode Timing**



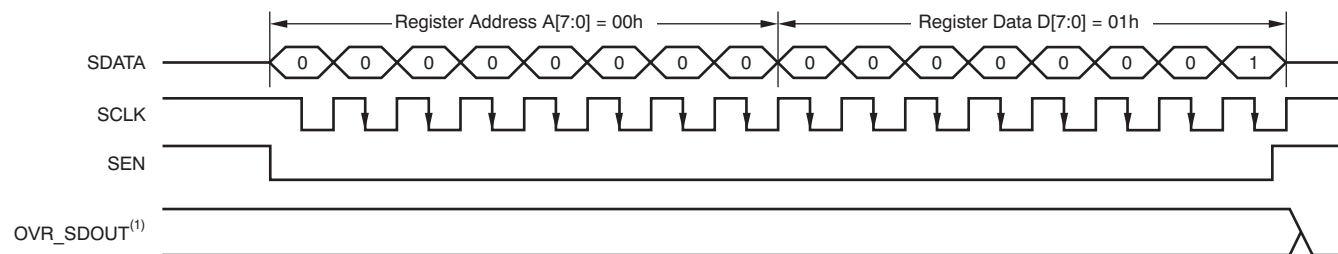
Dn = bits D0, D1, D2, and so forth.

**Figure 3. CMOS Mode Timing**

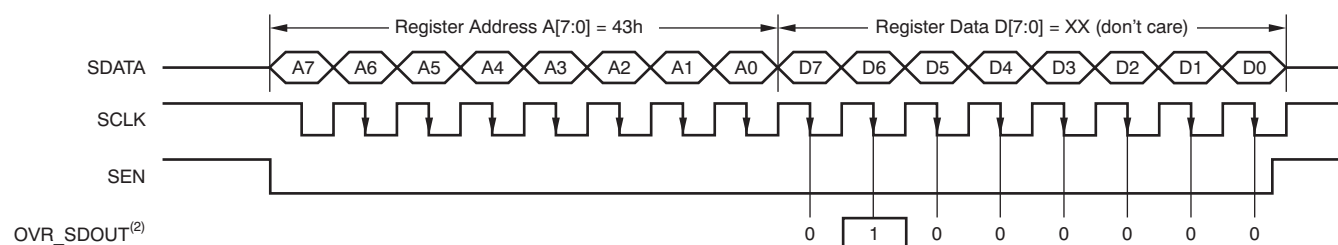


With external 100- $\Omega$  termination.

**Figure 4. LVDS Output Voltage Levels**



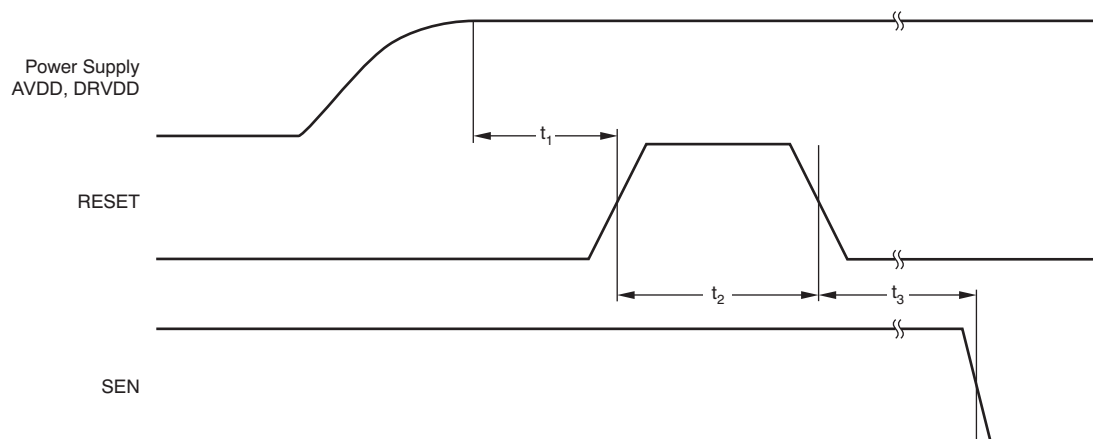
a) Enable Serial Readout (READOUT = 1)



b) Read Contents of Register 43h. This Register Has Been Initialized with 40h (device is put in global power-down mode).

The OVR\_SDOUT pin functions as OVR (READOUT = 0).

The OVR\_SDOUT pin functions as a serial readout (READOUT = 1).

**Figure 5. Serial Readout Timing Diagram**

A high pulse on the RESET pin is required in the serial interface mode in case of initialization through hardware reset. For parallel interface operation, RESET must be permanently tied high.

**Figure 6. Reset Timing Diagram**

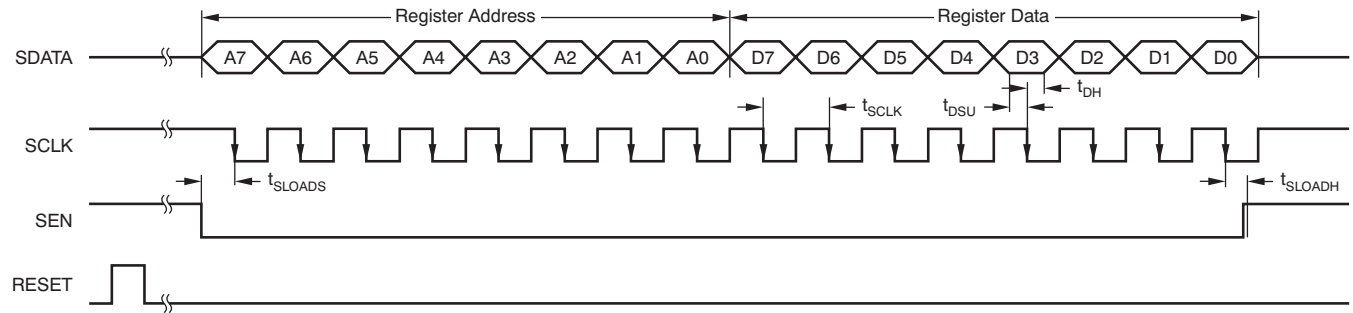


**Figure 7. Serial Interface Timing**

## 7.10 Typical Characteristics

At 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, maximum rated sampling frequency, sine wave input clock, 1.5-V<sub>PP</sub> differential clock amplitude, 50% clock duty cycle, –1-dBFS differential analog input, 0-dB gain, low-latency mode, DDR LVDS output interface, and 32k-point FFT, unless otherwise noted.

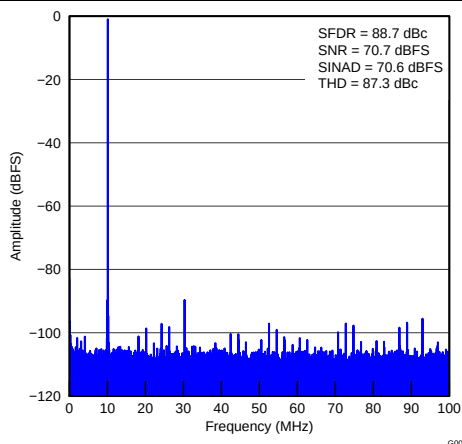


Figure 8. FFT for 10-MHz Input Signal

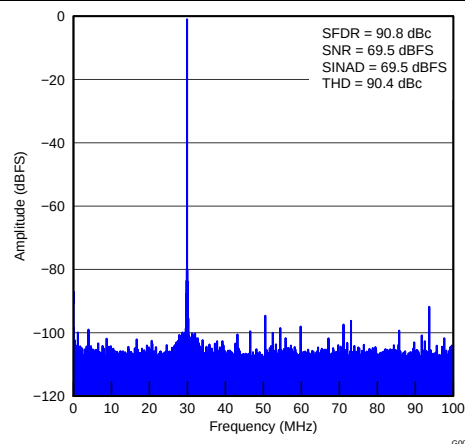


Figure 9. FFT for 170-MHz Input Signal

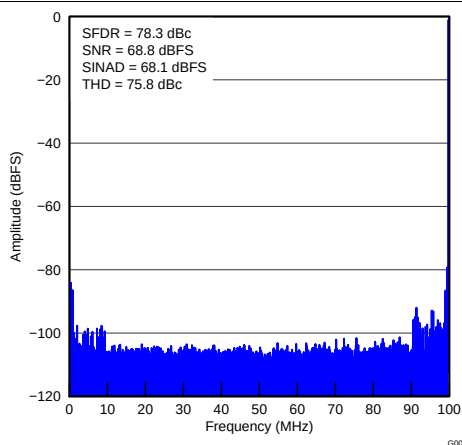


Figure 10. FFT for 300-MHz Input Signal

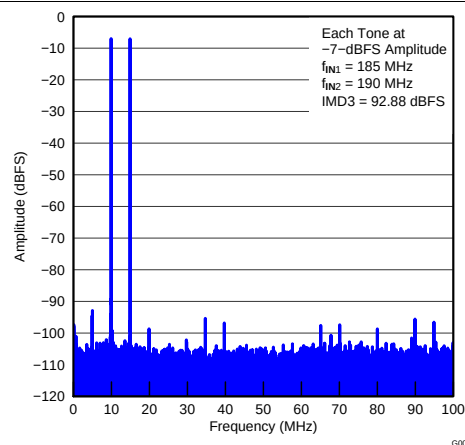


Figure 11. FFT for Two-Tone Input Signal

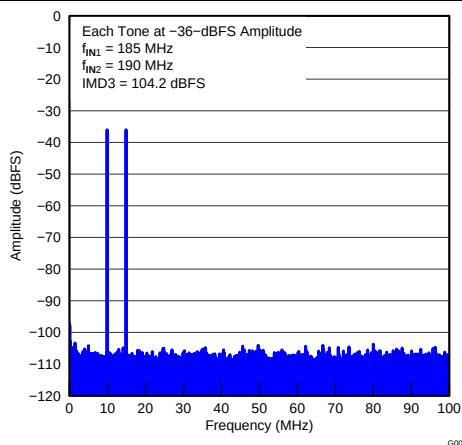


Figure 12. FFT for Two-Tone Input Signal

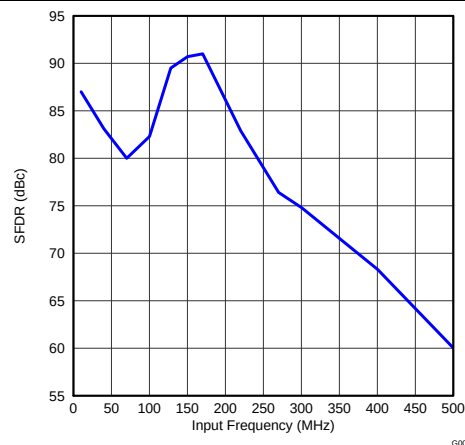


Figure 13. SFDR vs Input Frequency

## Typical Characteristics (continued)

At 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, maximum rated sampling frequency, sine wave input clock, 1.5-V<sub>PP</sub> differential clock amplitude, 50% clock duty cycle, -1-dBFS differential analog input, 0-dB gain, low-latency mode, DDR LVDS output interface, and 32k-point FFT, unless otherwise noted.

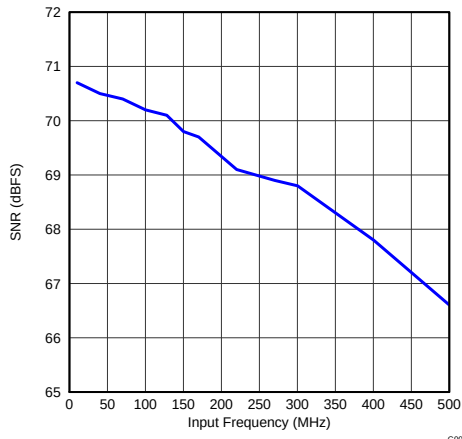


**Figure 14. SNR vs Input Frequency**

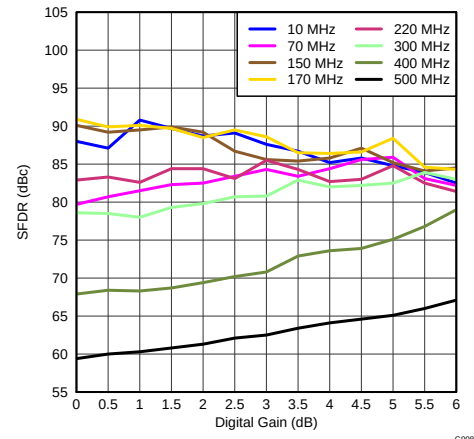


**Figure 15. SFDR vs Digital Gain**

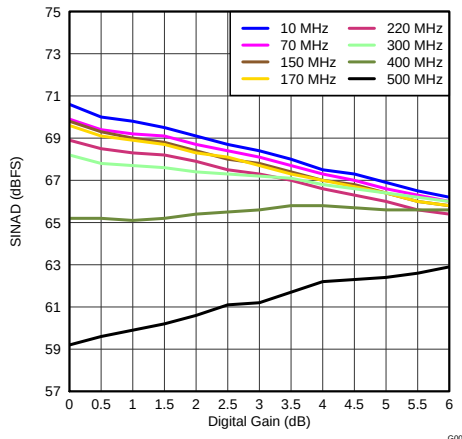


**Figure 16. SINAD vs Digital Gain**

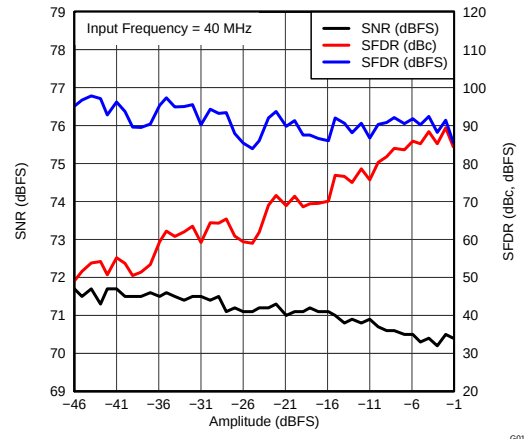


**Figure 17. Performance Across Input Amplitude**

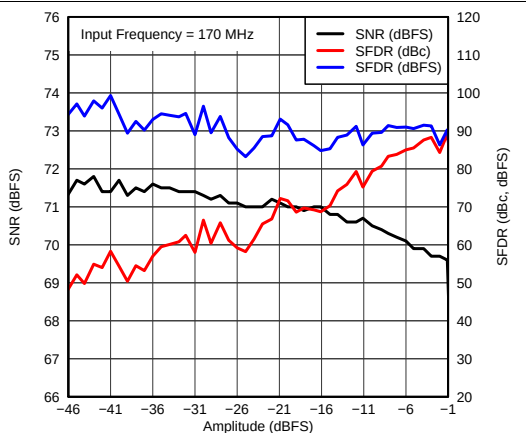


**Figure 18. Performance Across Input Amplitude**

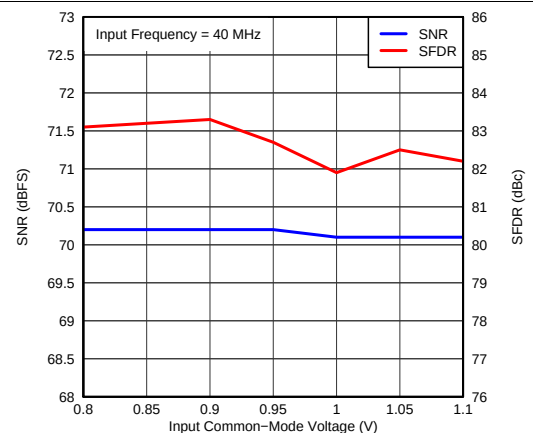


**Figure 19. Performance vs Input Common-Mode Voltage**

## Typical Characteristics (continued)

At 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, maximum rated sampling frequency, sine wave input clock, 1.5-V<sub>PP</sub> differential clock amplitude, 50% clock duty cycle, -1-dBFS differential analog input, 0-dB gain, low-latency mode, DDR LVDS output interface, and 32k-point FFT, unless otherwise noted.

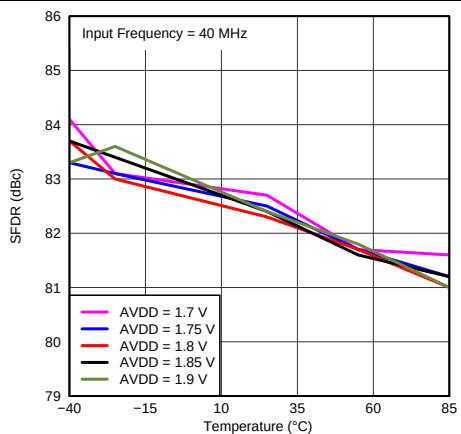


Figure 20. SFDR vs AVDD Supply and Temperature

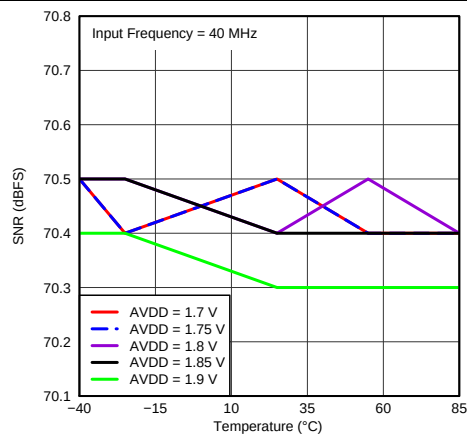


Figure 21. SNR vs AVDD Supply and Temperature

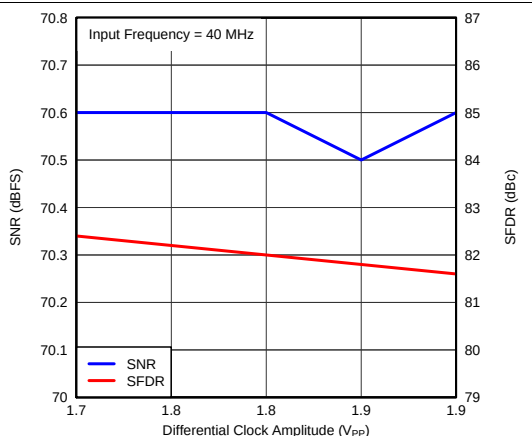


Figure 22. Performance vs DRVDD Supply

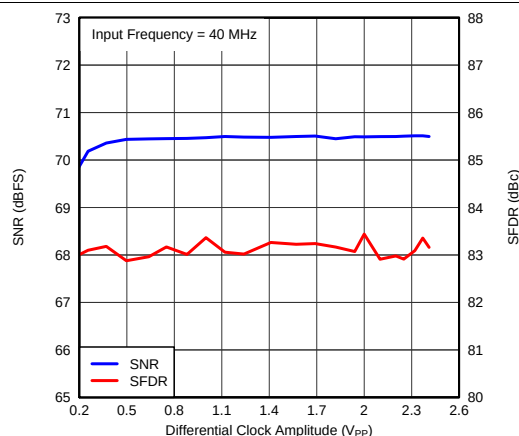


Figure 23. Performance vs Clock Amplitude

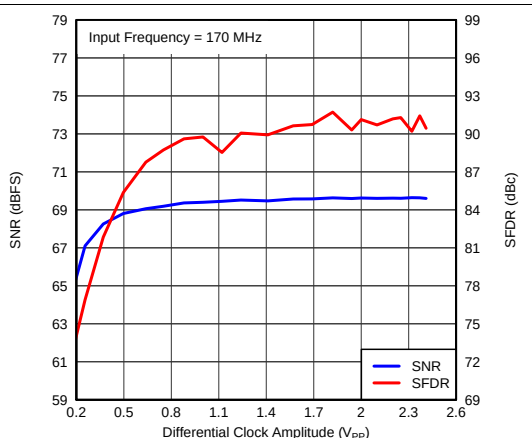


Figure 24. Performance vs Clock Amplitude

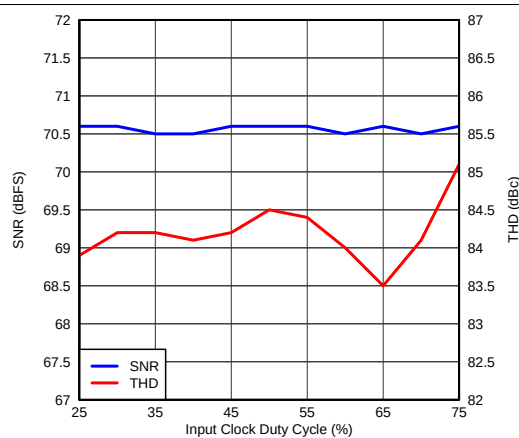


Figure 25. Performance vs Clock Duty Cycle

## Typical Characteristics (continued)

At 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, maximum rated sampling frequency, sine wave input clock, 1.5-V<sub>PP</sub> differential clock amplitude, 50% clock duty cycle, -1-dBFS differential analog input, 0-dB gain, low-latency mode, DDR LVDS output interface, and 32k-point FFT, unless otherwise noted.

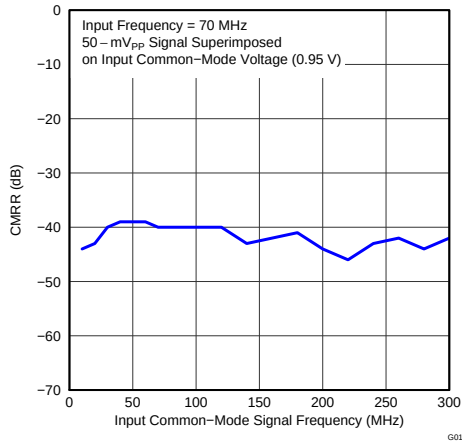


**Figure 26. CMRR vs Frequency**

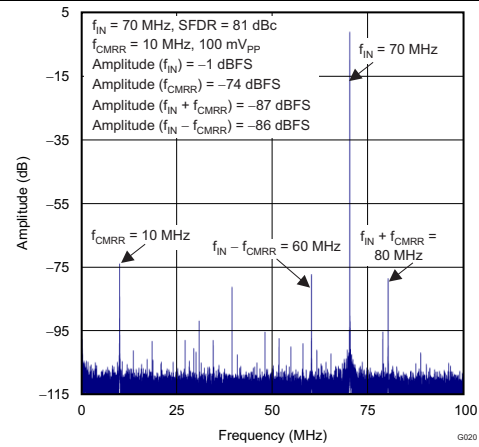


**Figure 27. CMRR Spectrum**

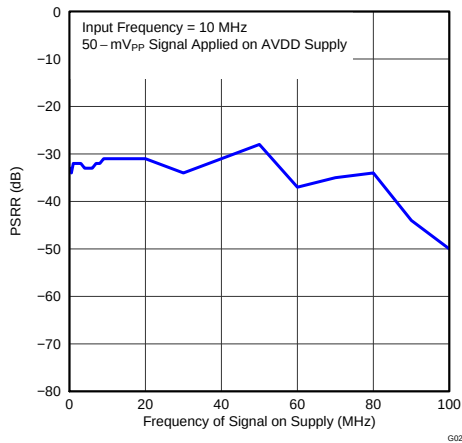


**Figure 28. PSRR vs Frequency**

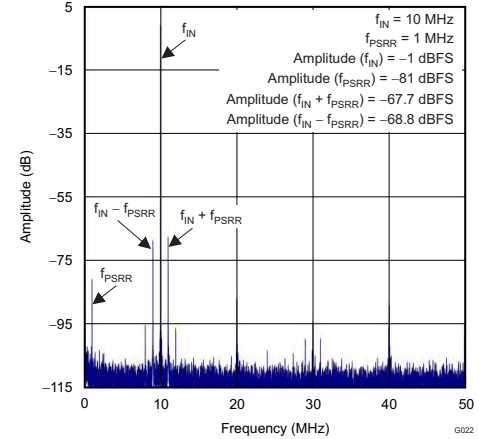


**Figure 29. Zoomed View of Spectrum With PSRR Signal**

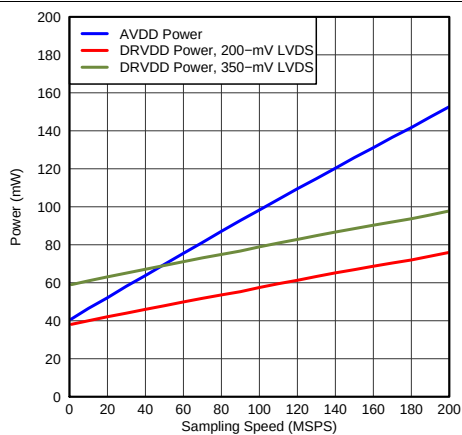


**Figure 30. Power vs Sampling Frequency**

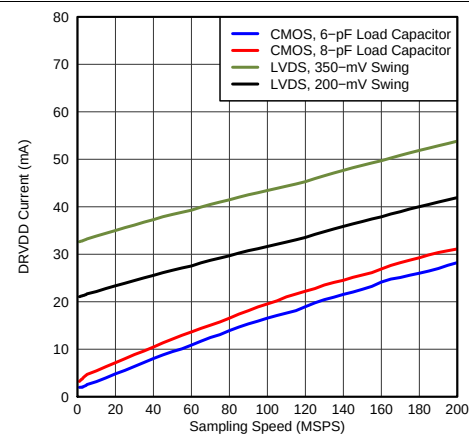


**Figure 31. DRVDD Current vs Sampling Frequency**

## 7.11 Typical Characteristics: Contour

At 25°C, AVDD = 1.8 V, DRVDD = 1.8 V, maximum rated sampling frequency, sine wave input clock, 1.5-V<sub>PP</sub> differential clock amplitude, 50% clock duty cycle, –1-dBFS differential analog input, 0-dB gain, low-latency mode, DDR LVDS output interface, and 32k-point FFT, unless otherwise noted.

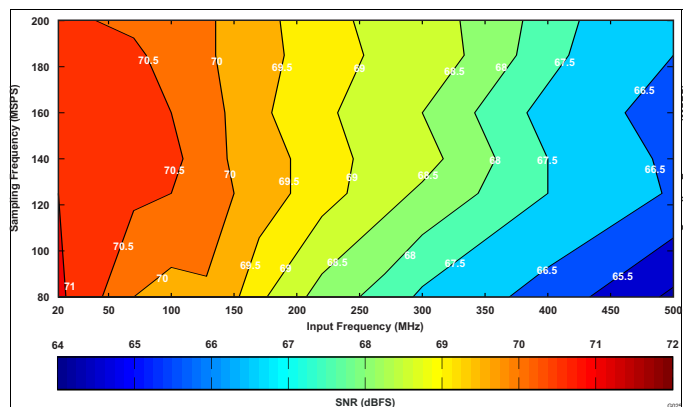
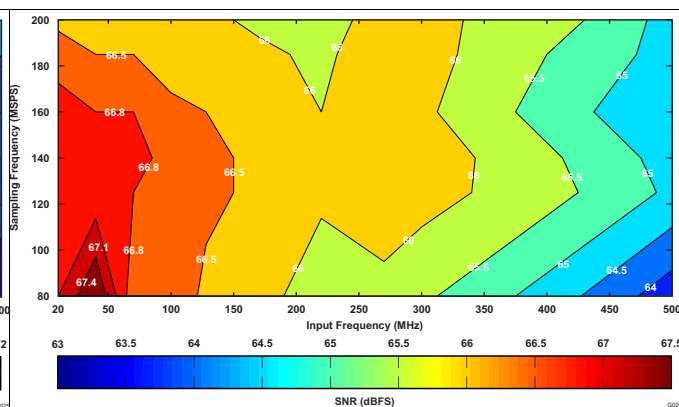


Figure 32. Signal-to-Noise Ratio (0-dB Gain)

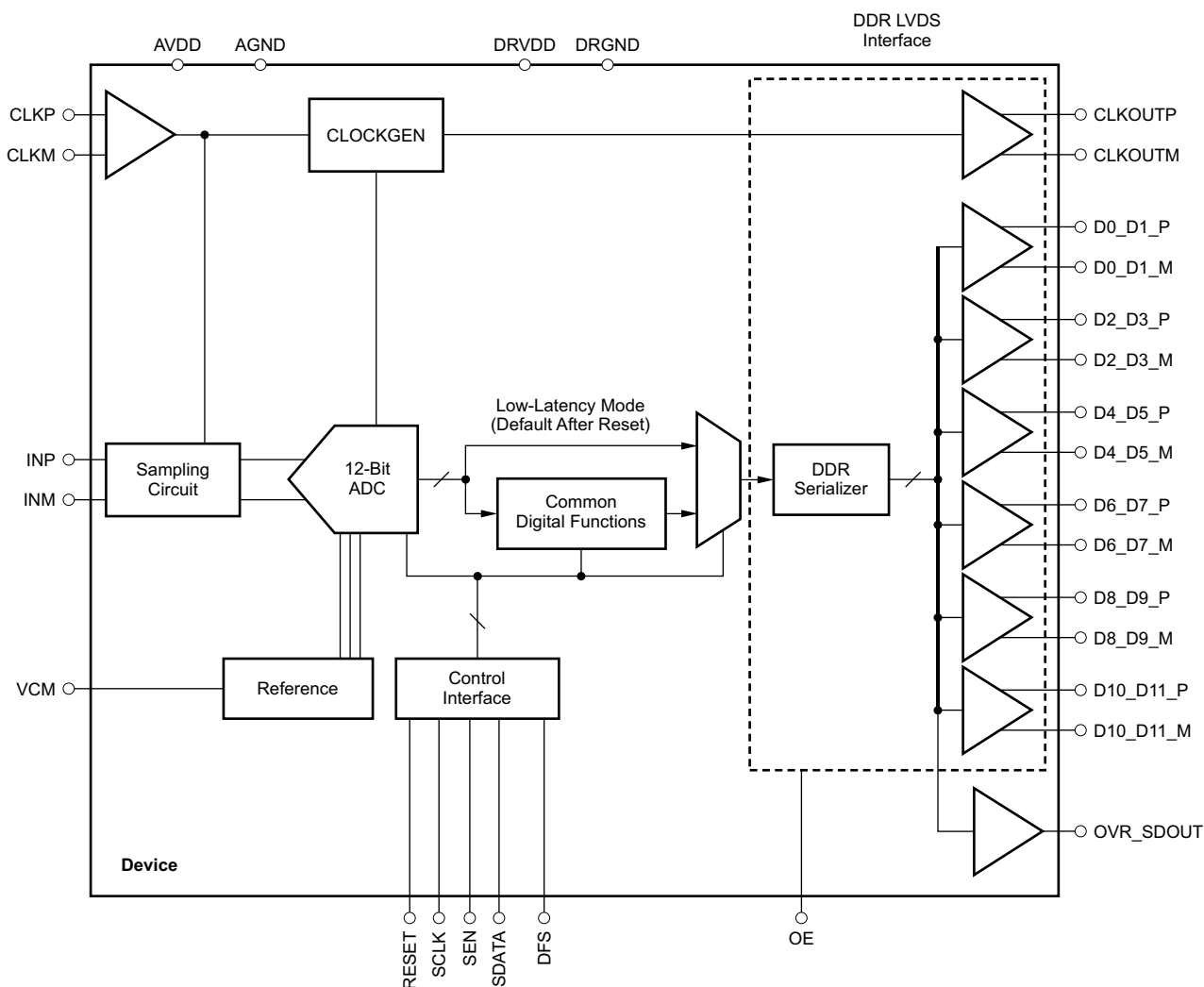


## 8 Detailed Description

### 8.1 Overview

The ADS4128 is a high-performance, low-power, 12-bit analog-to-digital converter (ADC) with maximum sampling rates up to 200 MSPS. The conversion process is initiated by a rising edge of the external input clock when the analog input signal is sampled. The sampled signal is sequentially converted by a series of small resolution stages, with the outputs combined in a digital correction logic block. At every clock edge the sample propagates through the pipeline, resulting in a data latency of 10 clock cycles. The output is available as 12-bit data, in DDR LVDS mode or CMOS mode, and coded in either straight offset binary or binary twos complement format.

### 8.2 Functional Block Diagram



## 8.3 Feature Description

### 8.3.1 Migrating From the ADS6149 Family

The ADS4128 is pin-compatible with the previous generation [ADS6149](#) family; this architecture enables easy migration. However, there are some important differences between the generations, as summarized in [Table 6](#).

**Table 6. Migrating From the ADS6149 Family**

| ADS6149 FAMILY                                           | ADS4149 FAMILY (Includes ADS4128)                                                                                                                |
|----------------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------|
| <b>PINS</b>                                              |                                                                                                                                                  |
| Pin 21 is NC (not connected)                             | Pin 21 is NC (not connected)                                                                                                                     |
| Pin 23 is MODE                                           | Pin 23 is RESERVED in the ADS4128. It is reserved as a digital control pin for an (as yet) undefined function in the next-generation ADC series. |
| <b>SUPPLY</b>                                            |                                                                                                                                                  |
| AVDD is 3.3 V                                            | AVDD is 1.8 V                                                                                                                                    |
| DRVDD is 1.8 V                                           | No change                                                                                                                                        |
| <b>INPUT COMMON-MODE VOLTAGE</b>                         |                                                                                                                                                  |
| VCM is 1.5 V                                             | VCM is 0.95 V                                                                                                                                    |
| <b>SERIAL INTERFACE</b>                                  |                                                                                                                                                  |
| Protocol: 8-bit register address and 8-bit register data | No change in protocol                                                                                                                            |
|                                                          | New serial register map                                                                                                                          |
| <b>EXTERNAL REFERENCE MODE</b>                           |                                                                                                                                                  |
| Supported                                                | Not supported                                                                                                                                    |
| ADS61B49 FAMILY                                          | ADS41B49 AND ADS58B18 FAMILY                                                                                                                     |
| <b>PINS</b>                                              |                                                                                                                                                  |
| Pin 21 is NC (not connected)                             | Pin 21 is 3.3-V AVDD_BUF (supply for the analog input buffers)                                                                                   |
| Pin 23 is MODE                                           | Pin 23 is a digital control pin for the RESERVED function. Pin 23 functions as SNR Boost enable (B18 only).                                      |
| <b>SUPPLY</b>                                            |                                                                                                                                                  |
| AVDD is 3.3 V                                            | AVDD is 1.8 V, AVDD_BUF is 3.3 V                                                                                                                 |
| DRVDD is 1.8 V                                           | No change                                                                                                                                        |
| <b>INPUT COMMON-MODE VOLTAGE</b>                         |                                                                                                                                                  |
| VCM is 1.5 V                                             | VCM is 1.7 V                                                                                                                                     |
| <b>SERIAL INTERFACE</b>                                  |                                                                                                                                                  |
| Protocol: 8-bit register address and 8-bit register data | No change in protocol<br>New serial register map                                                                                                 |
| <b>EXTERNAL REFERENCE MODE</b>                           |                                                                                                                                                  |
| Supported                                                | Not supported                                                                                                                                    |

### 8.3.2 Digital Functions and Low-Latency Mode

The device has several useful digital functions such as test patterns, gain, and offset correction. All of these functions require extra clock cycles for operation and increase the overall latency and power of the device. Alternately, the device has a low-latency mode in which the raw ADC output is routed to the output data pins with a latency of 10 clock cycles. In this mode, the digital functions are bypassed. [Figure 36](#) shows more details of the processing after the ADC.

The device is in low-latency mode after reset. In order to use any digital functions, low-latency mode must first be disabled by setting the DIS LOW LATENCY register bit to 1. Afterwards, the respective register bits must be programmed as described in the following sections and in the [Register Maps](#) section.

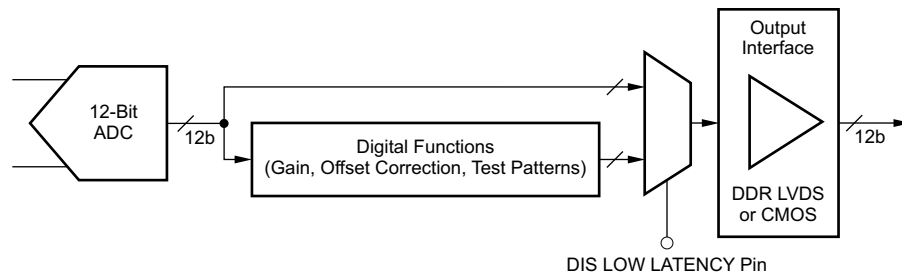


Figure 36. Digital Processing Block Diagram

### 8.3.3 Gain for SFDR and SNR Trade-Off

The ADS4128 includes gain settings that can be used to get improved SFDR performance. Gain is programmable from 0 dB to 6 dB (in 0.5-dB steps) using the GAIN register bits. For each gain setting, the analog input full-scale range scales proportionally, as shown in Table 7.

The SFDR improvement is achieved at the expense of SNR; for each gain setting, SNR degrades approximately between 0.5 dB and 1 dB. SNR degradation is reduced at high input frequencies. As a result, gain is very useful at high input frequencies because SFDR improvement is significant with marginal SNR degradation. Therefore, gain can be used to trade-off between SFDR and SNR.

After a reset, the device is in low-latency mode and the gain function is disabled. To use gain:

- First, disable low-latency mode (DIS LOW LATENCY = 1).
- This setting enables the gain and puts the device in a 0-dB gain mode.
- For other gain settings, program the GAIN bits.

Table 7. Full-Scale Range Across Gains

| GAIN (dB) | TYPE                | FULL-SCALE (V <sub>PP</sub> ) |
|-----------|---------------------|-------------------------------|
| 0         | Default after reset | 2                             |
| 1         | Programmable gain   | 1.78                          |
| 2         | Programmable gain   | 1.59                          |
| 3         | Programmable gain   | 1.42                          |
| 4         | Programmable gain   | 1.26                          |
| 5         | Programmable gain   | 1.12                          |
| 6         | Programmable gain   | 1.00                          |

### 8.3.4 Offset Correction

The ADS4128 has an internal offset correction algorithm that estimates and corrects dc offset up to ±10 mV. The correction can be enabled using the EN OFFSET CORR serial register bit. Once enabled, the algorithm estimates the channel offset and applies the correction every clock cycle. The correction loop time constant is a function of the sampling clock frequency. The time constant can be controlled using the OFFSET CORR TIME CONSTANT register bits, as described in Table 8.

Table 8. Offset Correction Loop Time Constant

| OFFSET CORR TIME CONSTANT | TIME CONSTANT, TC <sub>CLK</sub><br>(Number of Clock Cycles) | TIME CONSTANT, TC <sub>CLK</sub> × 1/f <sub>S</sub> (sec) <sup>(1)</sup> |
|---------------------------|--------------------------------------------------------------|--------------------------------------------------------------------------|
| 0000                      | 1 M                                                          | 4 ms                                                                     |
| 0001                      | 2 M                                                          | 8 ms                                                                     |
| 0010                      | 4 M                                                          | 16.7 ms                                                                  |
| 0011                      | 8 M                                                          | 33.5 ms                                                                  |
| 0100                      | 16 M                                                         | 67 ms                                                                    |
| 0101                      | 32 M                                                         | 134 ms                                                                   |

(1) Sampling frequency, f<sub>S</sub> = 200 MSPS.

**Table 8. Offset Correction Loop Time Constant (continued)**

| OFFSET CORR TIME CONSTANT | TIME CONSTANT, $TC_{CLK}$<br>(Number of Clock Cycles) | TIME CONSTANT, $TC_{CLK} \times 1/f_s$ (sec) <sup>(1)</sup> |
|---------------------------|-------------------------------------------------------|-------------------------------------------------------------|
| 0110                      | 64 M                                                  | 268 ms                                                      |
| 0111                      | 128 M                                                 | 537 ms                                                      |
| 1000                      | 256 M                                                 | 1.1 s                                                       |
| 1001                      | 512 M                                                 | 2.15 s                                                      |
| 1010                      | 1 G                                                   | 4.3 s                                                       |
| 1011                      | 2 G                                                   | 8.6 s                                                       |
| 1100                      | Reserved                                              | —                                                           |
| 1101                      | Reserved                                              | —                                                           |
| 1110                      | Reserved                                              | —                                                           |
| 1111                      | Reserved                                              | —                                                           |

After the offset is estimated, the correction can be frozen by setting FREEZE OFFSET CORR = 1. Once frozen, the last estimated value is used for every clock cycle offset correction. Note that offset correction is disabled by default after reset.

After a reset, the device is in low-latency mode and offset correction is disabled. To use offset correction:

- First, disable low-latency mode (DIS LOW LATENCY = 1).
- Then set EN OFFSET CORR to 1 and program the required time constant.

### 8.3.5 Power Down

The ADS4128 has three power-down modes: power-down global, standby, and output buffer disable.

#### 8.3.5.1 Global Power-Down

In this mode, the entire chip (including the ADC, internal reference, and the output buffers) are powered down, resulting in reduced total power dissipation of approximately 10 mW. The output buffers are in a high-impedance state. The wake-up time from the global power-down to data becoming valid in normal mode is typically 100  $\mu$ s. To enter the global power-down mode, set the PDN GLOBAL register bit.

#### 8.3.5.2 Standby

In this mode, only the ADC is powered down and the internal references are active, resulting in a fast wake-up time of 5  $\mu$ s. The total power dissipation in standby mode is approximately 185 mW. To enter standby mode, set the STBY register bit.

#### 8.3.5.3 Output Buffer Disable

The output buffers can be disabled and put in a high-impedance state; wakeup time from this mode is fast, approximately 100 ns. This mode can be controlled by using the PDN OBUF register bit or the OE pin.

#### 8.3.5.4 Input Clock Stop

In addition, the converter enters low-power mode when the input clock frequency falls below 1 MSPS. Power dissipation is approximately 80 mW.

### 8.3.6 Power-Supply Sequence

During power-up, the AVDD and DRVDD supplies can come up in any sequence. The two supplies are separated in the device. Externally, they can be driven from separate supplies or from a single supply.

### 8.3.7 Output Data Format

Two output data formats are supported: binary twos complement and offset binary. These formats can be selected by using the DATA FORMAT serial interface register bit or controlling the DFS pin in parallel configuration mode. In the event of an input voltage overdrive, the digital outputs go to the appropriate full-scale level.

## 8.4 Device Functional Modes

The ADS4128 has several modes that can be configured using a serial programming interface, as described in [Table 9](#), [Table 10](#), and [Table 11](#). In addition, the device has two dedicated parallel pins for quickly configuring commonly used functions. The parallel pins are DFS (analog 4-level control pin) and OE (digital control pin). The analog control pins can be easily configured using a simple resistor divider (with 10% tolerance resistors).

**Table 9. DFS: Analog Control Pin**

| VOLTAGE APPLIED ON DFS | DESCRIPTION<br>(DATA FORMAT AND OUTPUT INTERFACE) |
|------------------------|---------------------------------------------------|
| 0, 100 mV/–0 mV        | Twos complement and DDR LVDS                      |
| (3/8) AVDD ± 100 mV    | Twos complement and parallel CMOS                 |
| (5/8) AVDD ± 100 mV    | Offset binary and parallel CMOS                   |
| AVDD, 0 mV/–100 mV     | Offset binary and DDR LVDS                        |

**Table 10. OE: Digital Control Pin**

| VOLTAGE APPLIED ON OE | DESCRIPTION                  |
|-----------------------|------------------------------|
| 0                     | Output data buffers disabled |
| AVDD                  | Output data buffers enabled  |

When the serial interface is not used, the SDATA pin can also be used as a digital control pin to place the device in standby mode. To enable this, the RESET pin must be tied high. In this mode, SEN and SCLK do not have any alternative functions. Keep SEN tied high and SCLK tied low on the board.

**Table 11. SDATA: Digital Control Pin**

| VOLTAGE APPLIED ON SDATA | DESCRIPTION           |
|--------------------------|-----------------------|
| 0                        | Normal operation      |
| Logic high               | Device enters standby |

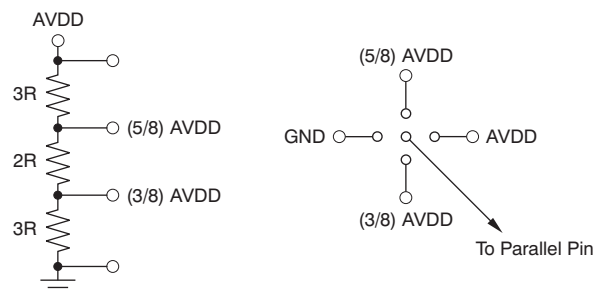


**Figure 37. Simplified Diagram to Configure DFS Pin**

**Table 12. High Performance Modes<sup>(1)(2)(3)</sup>**

| MODE   | DESCRIPTION                                                                                                                                        |
|--------|----------------------------------------------------------------------------------------------------------------------------------------------------|
| Mode 1 | Set the MODE 1 register bits to get best performance across sample clock and input signal frequencies. Register address = 03h, register data = 03h |
| Mode 2 | Set the MODE 2 register bit to get best performance at high input signal frequencies. Register address = 4Ah, register data = 01h                  |

- (1) It is recommended to use these modes to get best performance. These modes can be set using the serial interface only.
- (2) See the [Serial Interface](#) section for details on register programming.
- (3) Note that these modes cannot be set when the serial interface is not used (when the RESET pin is tied high); see the [Programming](#) section.

### 8.4.1 Output Interface Modes

The ADS4128 provides 12-bit data and an output clock synchronized with the data.

#### 8.4.1.1 Output Interface

Two output interface options are available: double data rate (DDR) LVDS and parallel CMOS. These modes can be selected by using the LVDS CMOS serial interface register bit or the DFS pin.

#### 8.4.1.2 DDR LVDS Outputs

In this mode, the data bits and clock are output using low voltage differential signal (LVDS) levels. Two data bits are multiplexed and output on each LVDS differential pair, as shown in Figure 38.

Even data bits (D0, D2, D4, and so on) are output at the CLKOUTP falling edge and the odd data bits (D1, D3, D5, and so on) are output at the CLKOUTP rising edge. Both the CLKOUTP rising and falling edges must be used to capture all 12 data bits, as shown in Figure 39.

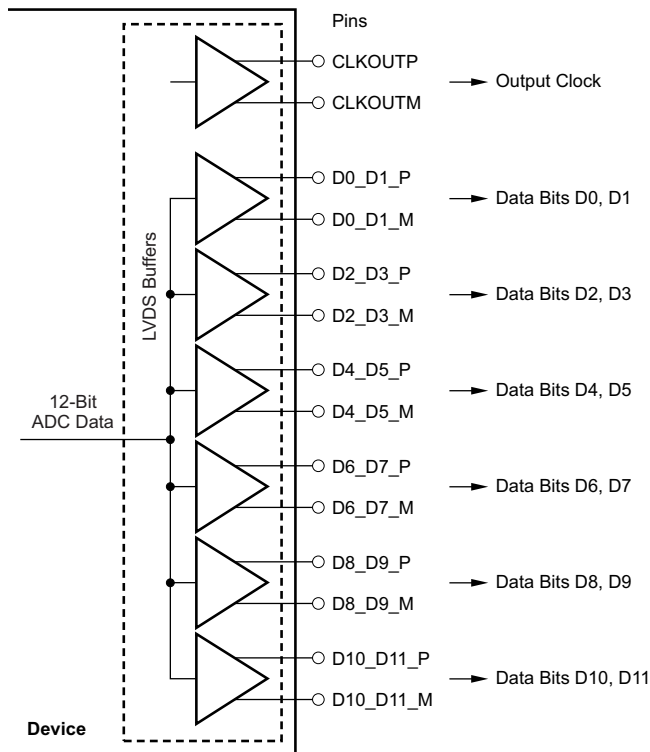


Figure 38. LVDS Data Outputs

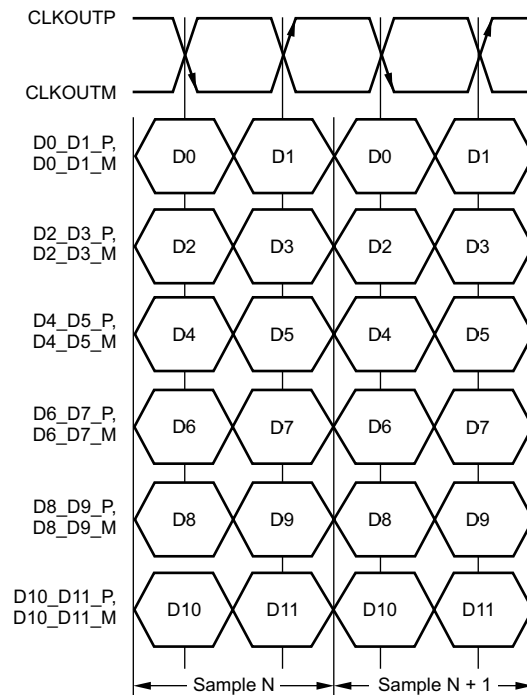


Figure 39. DDR LVDS Interface

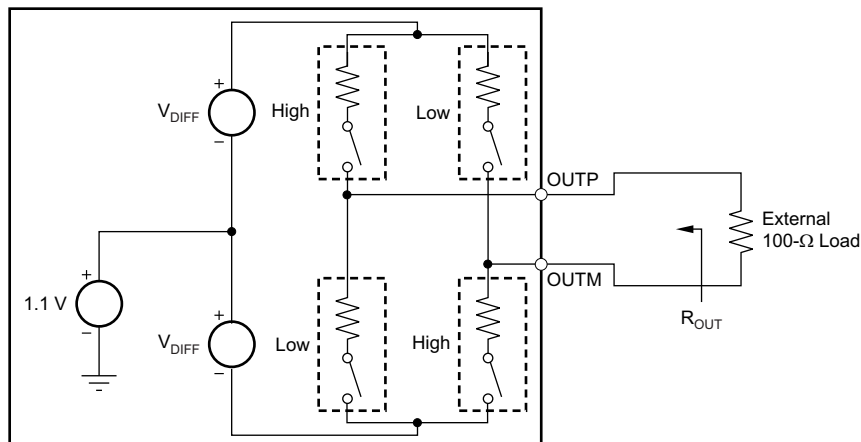
#### 8.4.1.3 LVDS Output Data and Clock Buffers

The equivalent circuit of each LVDS output buffer is shown in Figure 40. After reset, the buffer presents a 100-Ω output impedance to match the external 100-Ω termination.

$V_{DIFF}$  voltage is nominally 350 mV, resulting in a  $\pm 350$ -mV output swing with a 100-Ω external termination.  $V_{DIFF}$  voltage is programmable using the LVDS SWING register bits from  $\pm 125$  mV to  $\pm 570$  mV.

Additionally, a mode exists to double the LVDS buffer strength to support 50-Ω differential termination. This mode can be used when the output LVDS signal is routed to two separate receiver chips, each using a 100-Ω termination. This mode can be enabled using the LVDS DATA STRENGTH and LVDS CLKOUT STRENGTH register bits for data and output clock buffers, respectively.

The buffer output impedance behaves in the same way as a source-side series termination. By absorbing reflections from the receiver end, it helps to improve signal integrity.



NOTE: Use the default buffer strength to match the 100-Ω external termination ( $R_{OUT} = 100\ \Omega$ ). To match with a 50-Ω external termination, set the LVDS STRENGTH bit ( $R_{OUT} = 50\ \Omega$ ).

**Figure 40. LVDS Buffer Equivalent Circuit**

#### 8.4.1.4 Parallel CMOS Interface

In CMOS mode, each data bit is output on a separate pin as the CMOS voltage level, for every clock cycle. The output clock CLKOUT rising edge can be used to latch data in the receiver. [Figure 41](#) depicts the CMOS output interface.

Switching noise (caused by CMOS output data transitions) can couple into the analog inputs and degrade SNR. The coupling and SNR degradation increases as the output buffer drive is made stronger. To minimize this degradation, the CMOS output buffers are designed with controlled drive strength. The default drive strength ensures a wide data stable window (even at 200 MSPS) is provided so the data outputs have minimal load capacitance. It is recommended to use short traces (one to two inches or 2,54 cm to 5,08 cm) terminated with less than 5-pF load capacitance; see [Figure 42](#).

In some high-speed applications using CMOS interface, it may be required to use an external clock to capture data. For such cases, delay from the input clock to output data and the data valid times are specified for higher sampling frequencies. These timings can be used to delay the input clock appropriately and use it to capture data.

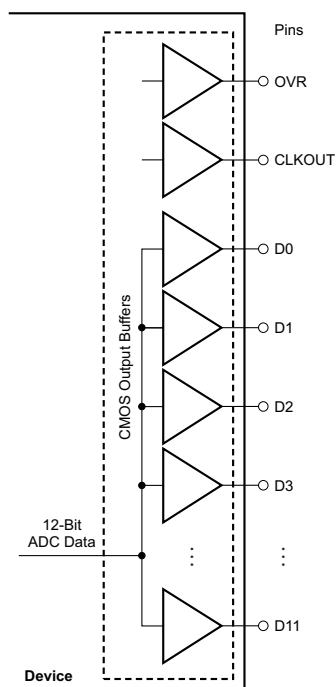


Figure 41. CMOS Output Interface

#### 8.4.1.5 CMOS Interface Power Dissipation

With CMOS outputs, the DRVDD current scales with the sampling frequency and load capacitance on every output pin. The maximum DRVDD current occurs when each output bit toggles between 0 and 1 every clock cycle. In actual applications, this condition is unlikely to occur. The actual DRVDD current is determined by the average number of output bits switching, which is a function of the sampling frequency and the nature of the analog input signal.

Digital Current as a Result of CMOS Output Switching =  $C_L \times \text{DRVDD} \times (N \times f_{\text{AVG}})$

where:

$C_L$  = load capacitance,

$N \times F_{\text{AVG}}$  = average number of output bits switching.

(1)

shows the current across sampling frequencies at a 2-MHz analog input frequency.

#### 8.4.1.6 Input Over-Voltage Indication (OVR Pin)

The device has an OVR pin that provides information about analog input overload. At any clock cycle, if the sampled input voltage exceeds the positive or negative full-scale range, the OVR pin goes high. OVR remains high as long as the overload condition persists. The OVR pin is a CMOS output buffer (running off of a DRVDD supply), independent of the output data interface (DDR LVDS or CMOS).

For a positive overload, the D[11:0] output data bits are FFFh in offset binary output format and 7FFh in twos complement output format. For a negative input overload, the output code is 000h in offset binary output format and 800h in twos complement output format.

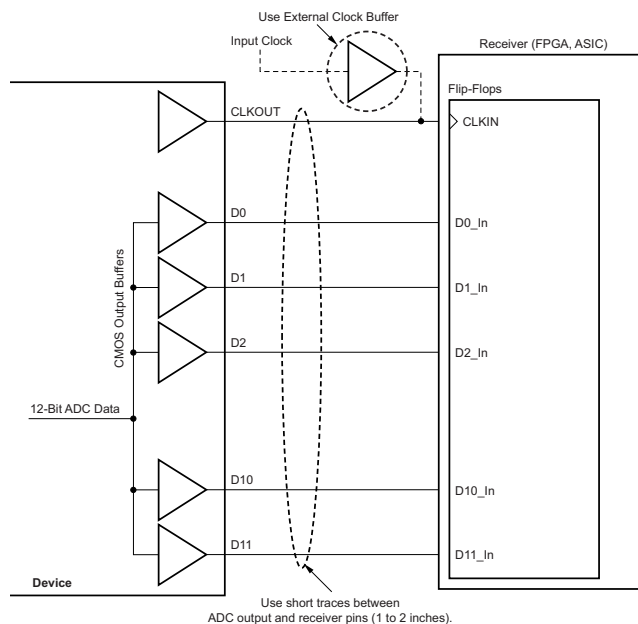


Figure 42. Using the CMOS Data Outputs

## 8.5 Programming

### 8.5.1 Serial Register Readout

The serial register readout function allows the contents of the internal registers to be read back on the OVR\_SDOUT pin. This readback may be useful as a diagnostic check to verify the serial interface communication between the external controller and the ADC.

After power-up and device reset, the OVR\_SDOUT pin functions as an over-range indicator pin by default. When the readout mode is enabled, OVR\_SDOUT outputs the contents of the selected register serially:

1. Set the READOUT register bit to 1. This setting puts the device in serial readout mode and disables any further writes to the internal registers **except** the register at address 0. Note that the READOUT bit itself is also located in register 0. The device can exit readout mode by writing READOUT = 0. Only the contents of the register at address 0 cannot be read in the register readout mode.
2. Initiate a serial interface cycle specifying the address of the register (A7 to A0) whose content has to be read.
3. The device serially outputs the contents (D7 to D0) of the selected register on the OVR\_SDOUT pin.
4. The external controller can latch the contents at the falling edge of SCLK.
5. To exit the serial readout mode, the reset register bit READOUT = 0 enables writes into all registers of the device. At this point, the OVR\_SDOUT pin becomes an over-range indicator pin.

### 8.5.2 Serial Interface

The analog-to-digital converter (ADC) has a set of internal registers that can be accessed by the serial interface formed by the SEN (serial interface enable), SCLK (serial interface clock), and SDATA (serial interface data) pins. Serial shift of bits into the device is enabled when SEN is low. Serial data SDATA are latched at every SCLK falling edge when SEN is active (low). The serial data are loaded into the register at every 16th SCLK falling edge when SEN is low. If the word length exceeds a multiple of 16 bits, the excess bits are ignored. Data can be loaded in multiples of 16-bit words within a single active SEN pulse. The first eight bits form the register address and the remaining eight bits are the register data. The interface can function with an SCLK frequency from 20 MHz down to very low speeds (of a few Hertz) and also with a non-50% SCLK duty cycle.

#### 8.5.2.1 Register Initialization

After power-up, the internal registers must be initialized to default values. This initialization can be accomplished in one of two ways:

1. Either through hardware reset by applying a high pulse on the RESET pin (of widths greater than 10 ns), as shown in [Figure 7](#); or
2. By applying a software reset. When using the serial interface, set the RESET bit (D7 in register 00h) high. This setting initializes the internal registers to default values and then self-resets the RESET bit low. In this case, the RESET pin is kept low.

## 8.6 Register Maps

[Serial Interface Register Map<sup>\(1\)</sup>](#) summarizes the functions supported by the serial interface.

### 8.6.1 Serial Interface Register Map<sup>(1)</sup>

| REGISTER ADDRESS | DEFAULT VALUE AFTER RESET | REGISTER DATA               |            |                           |          |                 |                  |                      |                    |
|------------------|---------------------------|-----------------------------|------------|---------------------------|----------|-----------------|------------------|----------------------|--------------------|
| A[7:0] (Hex)     | D[7:0] (Hex)              | D7                          | D6         | D5                        | D4       | D3              | D2               | D1                   | D0                 |
| 00               | 00                        | 0                           | 0          | 0                         | 0        | 0               | 0                | RESET                | READOUT            |
| 01               | 00                        | LVDS SWING                  |            |                           |          |                 |                  | 0                    | 0                  |
| 03               | 00                        | 0                           | 0          | 0                         | 0        | 0               | 0                | HIGH PERF MODE 1     |                    |
| 25               | 00                        | GAIN                        |            |                           |          | DISABLE GAIN    | TEST PATTERNS    |                      |                    |
| 26               | 00                        | 0                           | 0          | 0                         | 0        | 0               | 0                | LVDS CLKOUT STRENGTH | LVDS DATA STRENGTH |
| 3D               | 00                        | DATA FORMAT                 |            | EN OFFSET CORR            | 0        | 0               | 0                | 0                    | 0                  |
| 3F               | 00                        | CUSTOM PATTERN HIGH D[11:4] |            |                           |          |                 |                  |                      |                    |
| 40               | 00                        | CUSTOM PATTERN D[3:0]       |            |                           |          | 0               | 0                | 0                    | 0                  |
| 41               | 00                        | LVDS CMOS                   |            | CMOS CLKOUT STRENGTH      |          | EN CLKOUT RISE  | CLKOUT RISE POSN |                      | EN CLKOUT FALL     |
| 42               | 00                        | CLKOUT FALL POSN            |            | 0                         | 0        | DIS LOW LATENCY | STBY             | 0                    | 0                  |
| 43               | 00                        | 0                           | PDN GLOBAL | 0                         | PDN OBUF | 0               | 0                | EN LVDS SWING        |                    |
| 4A               | 00                        | 0                           | 0          | 0                         | 0        | 0               | 0                | 0                    | HIGH PERF MODE 2   |
| BF               | 00                        | OFFSET PEDESTAL             |            |                           |          |                 |                  | 0                    | 0                  |
| CF               | 00                        | FREEZE OFFSET CORR          | 0          | OFFSET CORR TIME CONSTANT |          |                 |                  | 0                    | 0                  |
| DF               | 00                        | 0                           | 0          | LOW SPEED                 |          | 0               | 0                | 0                    | 0                  |

(1) Multiple register functions can be programmed in a single write operation.

### 8.6.2 Register Description

For best performance, two special mode register bits must be enabled:

HI PERF MODE 1 and HI PERF MODE 2.

**Table 13. Register Address 00h (Default = 00h)**

| 7 | 6 | 5 | 4 | 3 | 2 | 1     | 0       |
|---|---|---|---|---|---|-------|---------|
| 0 | 0 | 0 | 0 | 0 | 0 | RESET | READOUT |

**Bits[7:2] Always write 0**

**Bit 1 RESET: Software reset applied**

This bit resets all internal registers to default values and self-clears to 0 (default = 1).

**Bit 0 READOUT: Serial readout**

This bit sets the serial readout of the registers.

0 = Serial readout of registers disabled; the OVR\_SDOOUT pin functions as an over-voltage indicator.

1 = Serial readout enabled; the OVR\_SDOOUT pin functions as a serial data readout.

**Table 14. Register Address 01h (Default = 00h)**

| 7          | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|------------|---|---|---|---|---|---|---|
| LVDS SWING |   |   |   |   |   | 0 | 0 |

**Bits[7:2] LVDS SWING: LVDS swing programmability<sup>(1)</sup>**

000000 = Default LVDS swing;  $\pm 350$  mV with external 100- $\Omega$  termination

011011 = LVDS swing *increases* to  $\pm 410$  mV

110010 = LVDS swing *increases* to  $\pm 465$  mV

010100 = LVDS swing *increases* to  $\pm 570$  mV

111110 = LVDS swing *decreases* to  $\pm 200$  mV

001111 = LVDS swing *decreases* to  $\pm 125$  mV

**Bits[1:0] Always write 0**

(1) The EN LVDS SWING register bits must be set to enable LVDS swing control.

**Table 15. Register Address 03h (Default = 00h)**

| 7 | 6 | 5 | 4 | 3 | 2 | 1              | 0 |
|---|---|---|---|---|---|----------------|---|
| 0 | 0 | 0 | 0 | 0 | 0 | HI PERF MODE 1 |   |

**Bits[7:2] Always write 0**
**Bits[1:0] HI PERF MODE 1: High-performance mode 1**

00 = Default performance after reset

01 = Do not use

10 = Do not use

11 = For best performance across sampling clock and input signal frequencies, set the HIGH PERF MODE 1 bits

**Table 16. Register Address 25h (Default = 00h)**

| 7    | 6 | 5 | 4 | 3            | 2             | 1 | 0 |
|------|---|---|---|--------------|---------------|---|---|
| GAIN |   |   |   | DISABLE GAIN | TEST PATTERNS |   |   |

**Bits[7:4] GAIN: Gain programmability**

These bits set the gain programmability in 0.5-dB steps.

0000 = 0-dB gain (default after reset)

0001 = 0.5-dB gain

0010 = 1.0-dB gain

0011 = 1.5-dB gain

0100 = 2.0-dB gain

0101 = 2.5-dB gain

0110 = 3.0-dB gain

0111 = 3.5-dB gain

1000 = 4.0-dB gain

1001 = 4.5-dB gain

1010 = 5.0-dB gain

1011 = 5.5-dB gain

1100 = 6.0-dB gain

**Bit 3 DISABLE GAIN: Gain setting**

This bit sets the gain.

0 = Gain enabled; gain is set by the GAIN bits only if low-latency mode is disabled

1 = Gain disabled

**Bits[2:0] TEST PATTERNS: Data capture**

These bits verify data capture.

000 = Normal operation

001 = Outputs all 0s

010 = Outputs all 1s

011 = Outputs toggle pattern

Output data D[11:0] is an alternating sequence of *010101010101* and *101010101010*.

100 = Outputs digital ramp

Output data increments by one LSB (12-bit) every fourth clock cycle from code 0 to code 4095

101 = Output custom pattern (use registers 3Fh and 40h for setting the custom pattern)

110 = Unused

111 = Unused

**Table 17. Register Address 26h (Default = 00h)**

| 7 | 6 | 5 | 4 | 3 | 2 | 1                    | 0                  |
|---|---|---|---|---|---|----------------------|--------------------|
| 0 | 0 | 0 | 0 | 0 | 0 | LVDS CLKOUT STRENGTH | LVDS DATA STRENGTH |

**Bits[7:2] Always write 0**

**Bit 1 LVDS CLKOUT STRENGTH: LVDS output clock buffer strength**

This bit determines the external termination to be used with the LVDS output clock buffer.

0 = 100-Ω external termination (default strength)

1 = 50-Ω external termination (2×strength)

**Bit 0 LVDS DATA STRENGTH: LVDS data buffer strength**

This bit determines the external termination to be used with all of the LVDS data buffers.

0 = 100-Ω external termination (default strength)

1 = 50-Ω external termination (2×strength)

**Table 18. Register Address 3Dh (Default = 00h)**

| 7           | 6              | 5 | 4 | 3 | 2 | 1 | 0 |
|-------------|----------------|---|---|---|---|---|---|
| DATA FORMAT | EN OFFSET CORR | 0 | 0 | 0 | 0 | 0 | 0 |

**Bits[7:6] DATA FORMAT: Data format selection**

These bits selects the data format.

00 = The DFS pin controls data format selection

10 = Twos complement

11 = Offset binary

**Bit 5 ENABLE OFFSET CORR: Offset correction setting**

This bit sets the offset correction.

0 = Offset correction disabled

1 = Offset correction enabled

**Bits[4:0] Always write 0**

**Table 19. Register Address 3Fh (Default = 00h)**

| 7                  | 6                  | 5                 | 4                 | 3                 | 2                 | 1                 | 0                 |
|--------------------|--------------------|-------------------|-------------------|-------------------|-------------------|-------------------|-------------------|
| CUSTOM PATTERN D11 | CUSTOM PATTERN D10 | CUSTOM PATTERN D9 | CUSTOM PATTERN D8 | CUSTOM PATTERN D7 | CUSTOM PATTERN D6 | CUSTOM PATTERN D5 | CUSTOM PATTERN D4 |

**Bits[7:0] CUSTOM PATTERN**

These bits set the custom pattern.

**Table 20. Register Address 40h (Default = 00h)**

| 7                 | 6                 | 5                 | 4                 | 3 | 2 | 1 | 0 |
|-------------------|-------------------|-------------------|-------------------|---|---|---|---|
| CUSTOM PATTERN D3 | CUSTOM PATTERN D2 | CUSTOM PATTERN D1 | CUSTOM PATTERN D0 | 0 | 0 | 0 | 0 |

**Bits[7:2] CUSTOM PATTERN**

These bits set the custom pattern.

**Bits[3:0] Always write 0**
**Table 21. Register Address 41h (Default = 00h)**

| 7         | 6                    | 5 | 4 | 3              | 2                | 1 | 0              |
|-----------|----------------------|---|---|----------------|------------------|---|----------------|
| LVDS CMOS | CMOS CLKOUT STRENGTH |   |   | EN CLKOUT RISE | CLKOUT RISE POSN |   | EN CLKOUT FALL |

**Bits[7:6] LVDS CMOS: Interface selection**

These bits select the interface.

00 = The DFS pin controls the selection of either LVDS or CMOS interface

10 = The DFS pin controls the selection of either LVDS or CMOS interface

01 = DDR LVDS interface

11 = Parallel CMOS interface

**Bits[5:4] CMOS CLKOUT STRENGTH**

Controls strength of CMOS output clock only.

00 = Maximum strength (recommended and used for specified timings)

01 = Medium strength

10 = Low strength

11 = Very low strength

**Bit 3 ENABLE CLKOUT RISE**

0 = Disables control of output clock rising edge

1 = Enables control of output clock rising edge

**Bits[2:1] CLKOUT RISE POSN: CLKOUT rise control**

Controls position of output clock rising edge

LVDS interface:

00 = Default position (timings are specified in this condition)

01 = Setup reduces by 500 ps, hold increases by 500 ps

10 = Data transition is aligned with rising edge

11 = Setup reduces by 200 ps, hold increases by 200 ps

CMOS interface:

00 = Default position (timings are specified in this condition)

01 = Setup reduces by 100 ps, hold increases by 100 ps

10 = Setup reduces by 200 ps, hold increases by 200 ps

11 = Setup reduces by 1.5 ns, hold increases by 1.5 ns

**Bit 0 ENABLE CLKOUT FALL**

0 = Disables control of output clock falling edge

1 = Enables control of output clock falling edge

**Table 22. Register Address 42h (Default = 00h)**

| 7                | 6 | 5 | 4 | 3               | 2    | 1 | 0 |
|------------------|---|---|---|-----------------|------|---|---|
| CLKOUT FALL CTRL |   | 0 | 0 | DIS LOW LATENCY | STBY | 0 | 0 |

**Bits[7:6] CLKOUT FALL CTRL**

Controls position of output clock falling edge

LVDS interface:

00 = Default position (timings are specified in this condition)

01 = Setup reduces by 400 ps, hold increases by 400 ps

10 = Data transition is aligned with rising edge

11 = Setup reduces by 200 ps, hold increases by 200 ps

CMOS interface:

00 = Default position (timings are specified in this condition)

01 = Falling edge is advanced by 100 ps

10 = Falling edge is advanced by 200 ps

11 = Falling edge is advanced by 1.5 ns

**Bits[5:4] Always write 0****Bit 3 DIS LOW LATENCY: Disable low latency**

This bit disables low-latency mode.

0 = Low-latency mode is enabled. Digital functions such as gain, test patterns, and offset correction are disabled.

1 = Low-latency mode is disabled. This setting enables the digital functions. See the [Digital Functions and Low-Latency Mode](#) section.

**Bit 2 STBY: Standby mode**

This bit sets the standby mode.

0 = Normal operation

1 = Only the ADC and output buffers are powered down; internal reference is active; wake-up time from standby is fast

**Bits[1:0] Always write 0**

**Table 23. Register Address 43h (Default = 00h)**

| 7 | 6          | 5 | 4        | 3 | 2 | 1             | 0 |
|---|------------|---|----------|---|---|---------------|---|
| 0 | PDN GLOBAL | 0 | PDN OBUF | 0 | 0 | EN LVDS SWING |   |

**Bit 0 Always write 0****Bit 6 PDN GLOBAL: Power-down**

This bit sets the state of operation.

0 = Normal operation

1 = Total power down; the ADC, internal references, and output buffers are powered down; slow wake-up time.

**Bit 5 Always write 0****Bit 4 PDN OBUF: Power-down output buffer**

This bit set the output data and clock pins.

0 = Output data and clock pins enabled

1 = Output data and clock pins powered down and put in high-impedance state

**Bits[3:2] Always write 0****Bits[1:0] EN LVDS SWING: LVDS swing control**

00 = LVDS swing control using LVDS SWING register bits is disabled

01 = Do not use

10 = Do not use

11 = LVDS swing control using LVDS SWING register bits is enabled

**Table 24. Register Address 4Ah (Default = 00h)**

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0                 |
|---|---|---|---|---|---|---|-------------------|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | HI PERF<br>MODE 2 |

**Bits[7:1]** Always write 0

**Bit[0]** **HI PERF MODE 2: High-performance mode 2**

This bit is recommended for high input signal frequencies greater than 230 MHz.

0 = Default performance after reset

1 = For best performance with high-frequency input signals, set the HIGH PERF MODE 2 bit

**Table 25. Register Address BFh (Default = 00h)**

| 7               | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-----------------|---|---|---|---|---|---|---|
| OFFSET PEDESTAL |   |   |   | 0 | 0 | 0 | 0 |

**Bits[7:4]** **OFFSET PEDESTAL**

These bits set the offset pedestal.

When the offset correction is enabled, the final converged value after the offset is corrected is the ADC mid-code value. A pedestal can be added to the final converged value by programming these bits.

| OFFSET PEDESTAL VALUE | PEDESTAL |
|-----------------------|----------|
| 0111                  | 7 LSB    |
| 0110                  | 6 LSB    |
| 0101                  | 5 LSB    |
| —                     | —        |
| 000000                | 0 LSB    |
| —                     | —        |
| 1111                  | –1 LSB   |
| 1110                  | –2 LSB   |
| —                     | —        |
| 1000                  | –8 LSB   |

**Bits[3:0]** Always write 0

**Table 26. Register Address CFh (Default = 00h)**

| 7                        | 6                        | 5                         | 4 | 3 | 2 | 1 | 0 |
|--------------------------|--------------------------|---------------------------|---|---|---|---|---|
| FREEZE<br>OFFSET<br>CORR | BYPASS<br>OFFSET<br>CORR | OFFSET CORR TIME CONSTANT |   |   |   | 0 | 0 |

**Bit 7** **FREEZE OFFSET CORR**

This bit sets the freeze offset correction.

0 = Estimation of offset correction is not frozen (bit EN OFFSET CORR must be set)

1 = Estimation of offset correction is frozen (bit EN OFFSET CORR must be set). When frozen, the last estimated value is used for offset correction every clock cycle. See [Offset Correction](#).

**Bit 6** Always write 0

**Bits[5:2]** **OFFSET CORR TIME CONSTANT**

These bits set the offset correction time constant for the correction loop time constant in number of clock cycles.

|       |                                        |
|-------|----------------------------------------|
| VALUE | TIME CONSTANT (Number of Clock Cycles) |
|-------|----------------------------------------|

|      |       |
|------|-------|
| 0000 | 1 M   |
| 0001 | 2 M   |
| 0010 | 4 M   |
| 0011 | 8 M   |
| 0100 | 16 M  |
| 0101 | 32 M  |
| 0110 | 64 M  |
| 0111 | 128 M |
| 1000 | 256 M |
| 1001 | 512 M |
| 1010 | 1 G   |
| 1011 | 2 G   |

**Bits[1:0]** Always write 0

**Table 27. Register Address DFh (Default = 00h)**

| 7 | 6 | 5         | 4 | 3 | 2 | 1 | 0 |
|---|---|-----------|---|---|---|---|---|
| 0 | 0 | LOW SPEED |   | 0 | 0 | 0 | 0 |

**Bits[7:1]** Always write 0

**Bit 0** **LOW SPEED: Low-speed mode**

00, 01, 10 = Low-speed mode disabled (default state after reset); this setting is recommended for sampling rates greater than 80 MSPS.

11 = Low-speed mode enabled; this setting is recommended for sampling rates less than or equal to 80 MSPS.

## 9 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

#### 9.1.1 Analog Input

The analog input consists of a switched-capacitor-based, differential, sample-and-hold architecture. This differential topology results in very good ac performance even for high input frequencies at high sampling rates. The INP and INM pins must be externally biased around a common-mode voltage of 0.95 V, available on the VCM pin. For a full-scale differential input, each input INP and INM pin must swing symmetrically between  $(V_{CM} + 0.5\text{ V})$  and  $(V_{CM} - 0.5\text{ V})$ , resulting in a  $2\text{-}V_{PP}$  differential input swing. The input sampling circuit has a high 3-dB bandwidth that extends up to 550 MHz (measured from the input pins to the sampled voltage). [Figure 43](#) shows an equivalent circuit for the analog input.

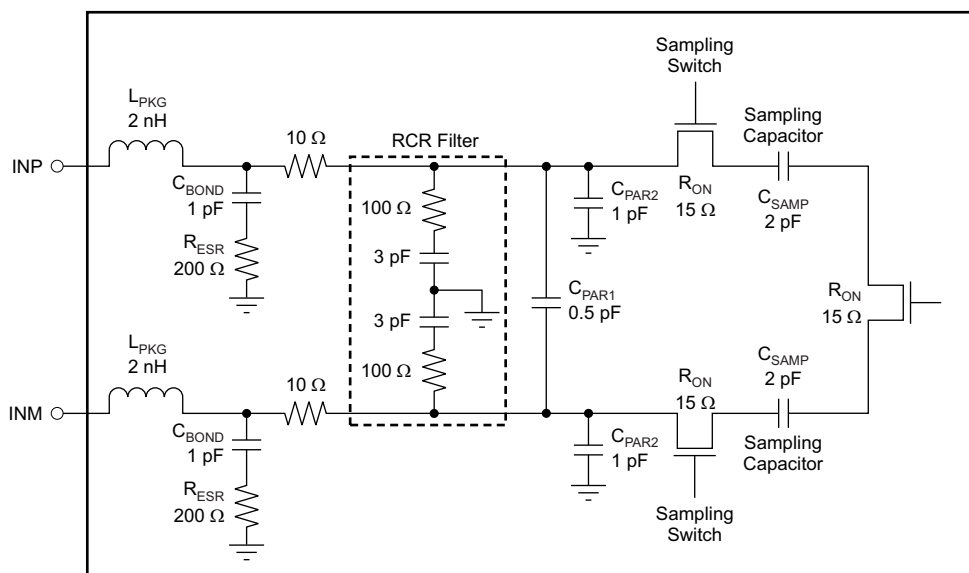


Figure 43. Analog Input Equivalent Circuit

## Application Information (continued)

### 9.1.2 Driving Circuit

Two example driving circuit configurations are shown in [Figure 44](#) and [Figure 45](#)—one is optimized for low bandwidth and the other is optimized for high bandwidth to support higher input frequencies. In [Figure 44](#), an external R-C-R filter with 3.3 pF is used to help absorb sampling glitches. The R-C-R filter limits the drive circuit bandwidth, making it suitable for low input frequencies (up to 250 MHz). Transformers such as ADT1-1WT or WBC1-1 can be used up to 250 MHz.

For higher input frequencies, the R-C-R filter can be dropped. Together with the lower series resistors (5  $\Omega$  to 10  $\Omega$ ), this drive circuit provides higher bandwidth to support frequencies up to 500 MHz (as shown in [Figure 45](#)). A transmission line transformer (such as ADTL2-18) can be used.

Note that both drive circuits are terminated by 50  $\Omega$  near the ADC side. The termination is accomplished by a 25- $\Omega$  resistor from each input to the 0.95-V common-mode (VCM) from the device. This termination allows the analog inputs to be biased around the required common-mode voltage.

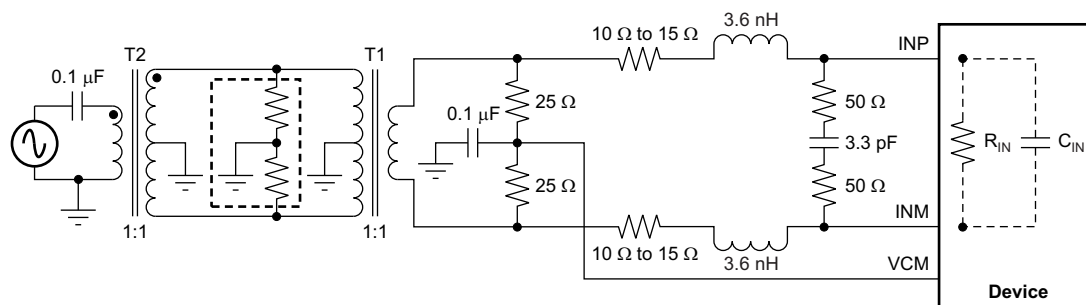


**Figure 44. Drive Circuit with Low Bandwidth (for Low Input Frequencies)**

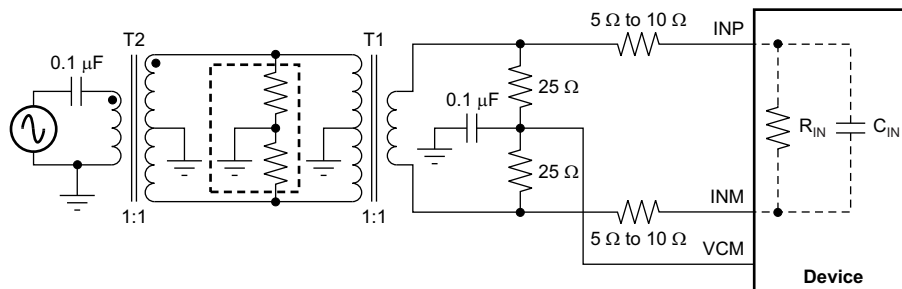


**Figure 45. Drive Circuit with High Bandwidth (for High Input Frequencies)**

The transformer parasitic capacitance mismatch (between the windings) results in degraded even-order harmonic performance. Connecting two identical RF transformers back-to-back helps minimize this mismatch and good performance is obtained for high-frequency input signals. An additional termination resistor pair may be required between the two transformers; refer to [Figure 44](#) and [Figure 45](#). The termination center point is connected to ground to improve the balance between the P (positive) and M (negative) sides. The termination values between the transformers and on the secondary side must be chosen to obtain an effective 50  $\Omega$  (for a 50- $\Omega$  source impedance).

[Figure 44](#) and [Figure 45](#) use 1:1 transformers with a 50- $\Omega$  source. As explained in the [Drive Circuit Requirements](#) section, this architecture helps to present a low source impedance to absorb sampling glitches. With a 1:4 transformer, the source impedance is 200  $\Omega$ . The higher source impedance is unable to absorb the sampling glitches effectively and can lead to degradation in performance (compared to using 1:1 transformers).

In almost all cases, either a band-pass or low-pass filter is needed to get the desired dynamic performance, as shown in [Figure 46](#). Such a filter presents low source impedance at the high frequencies corresponding to the sampling glitch and helps avoid performance loss with the high source impedance.

## Application Information (continued)

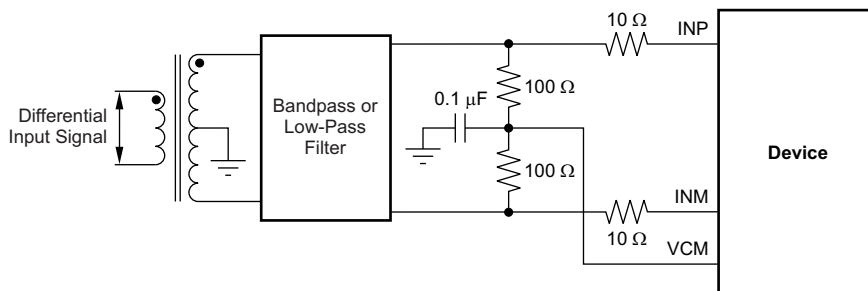


Figure 46. Drive Circuit with 1:4 Transformer

### 9.1.2.1 Drive Circuit Requirements

For optimum performance, the analog inputs must be driven differentially. This technique improves the common-mode noise immunity and even-order harmonic rejection. A 5-Ω to 15-Ω resistor in series with each input pin is recommended to damp out ringing caused by package parasitics. It is also necessary to present low impedance (less than 50 Ω) for the common-mode switching currents. This impedance can be achieved by using two resistors from each input terminated to the common-mode voltage (VCM).

Note that the device includes an internal R-C filter from each input to ground. The purpose of this filter is to absorb the glitches created when the sampling capacitors open and close. The R-C filter cutoff frequency involves a trade-off. A lower cutoff frequency (larger C) absorbs glitches better, but also reduces the input bandwidth and maximum input frequency that can be supported. On the other hand, with no internal R-C filter, high input frequency can be supported but now the sampling glitches must be supplied by the external driving circuit. The inductance of the package bond wires limits the ability of the external driving circuit to support the sampling glitches.

In the ADS4128, the R-C component values have been optimized while supporting high input bandwidth (550 MHz). However, in applications where very high input frequency support is not required, glitch filtering can be further improved with an external R-C-R filter; see Figure 44 and Figure 45).

In addition, the drive circuit may have to be designed to provide a low insertion loss over the desired frequency range and matched source impedance. While designing the drive circuit, the ADC impedance must be considered. Figure 47 and Figure 48 show the impedance ( $Z_{IN} = R_{IN} \parallel C_{IN}$ ) looking into the ADC input pins.

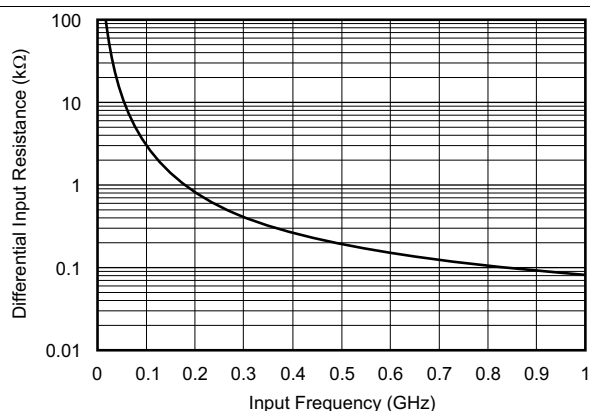


Figure 47. ADC Analog Input Resistance ( $R_{IN}$ ) Across Frequency

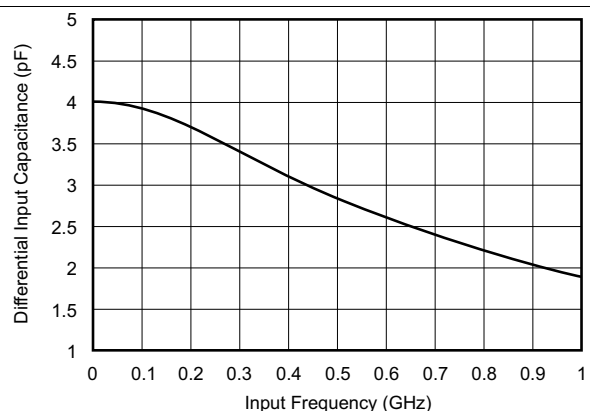


Figure 48. ADC Analog Input Capacitance ( $C_{IN}$ ) Across Frequency

## Application Information (continued)

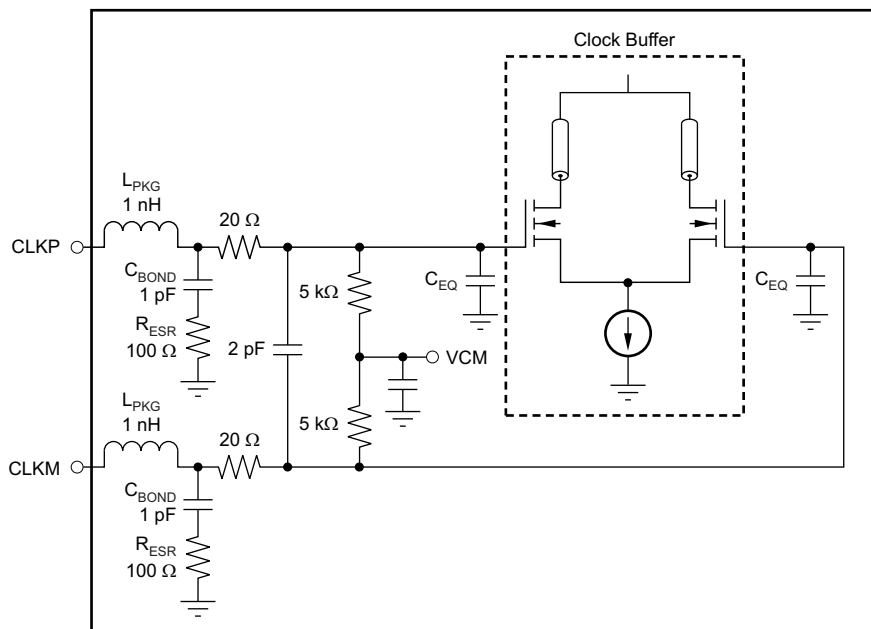
### 9.1.3 Analog Input

#### 9.1.3.1 Input Common-Mode

To ensure a low-noise, common-mode reference, the VCM pin is filtered with a 0.1- $\mu$ F low-inductance capacitor connected to ground. The VCM pin is designed to directly drive the ADC inputs. Each ADC input pin sinks a common-mode current of approximately 0.6  $\mu$ A per MSPS of clock frequency.

#### 9.1.4 Clock Input

The ADS4128 clock inputs can be driven differentially (sine, LVPECL, or LVDS) or single-ended (LVCMOS), with little or no difference in performance between them. The common-mode voltage of the clock inputs is set to VCM using internal 5-k $\Omega$  resistors. This setting allows the use of transformer-coupled drive circuits for sine-wave clock or ac-coupling for LVPECL and LVDS clock sources. Figure 49 shows an equivalent circuit for the input clock.



NOTE:  $C_{EQ}$  is 1 pF to 3 pF and is the equivalent input capacitance of the clock buffer.

**Figure 49. Input Clock Equivalent Circuit**

A single-ended CMOS clock can be ac-coupled to the CLKP input, with CLKM connected to ground with a 0.1- $\mu$ F capacitor, as shown in Figure 50. For best performance, the clock inputs must be driven differentially, reducing susceptibility to common-mode noise. For high input frequency sampling, it is recommended to use a clock source with very low jitter. Band-pass filtering of the clock source can help reduce the effects of jitter. There is no change in performance with a non-50% duty cycle clock input. Figure 51 shows a differential circuit.

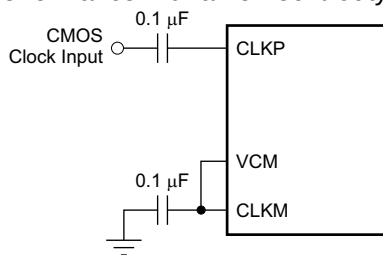


**Figure 50. Single-Ended Clock Driving Circuit**

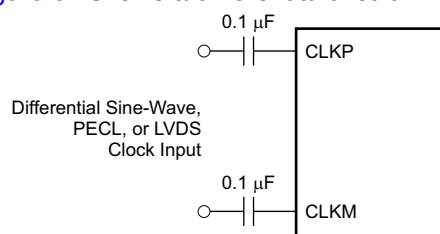
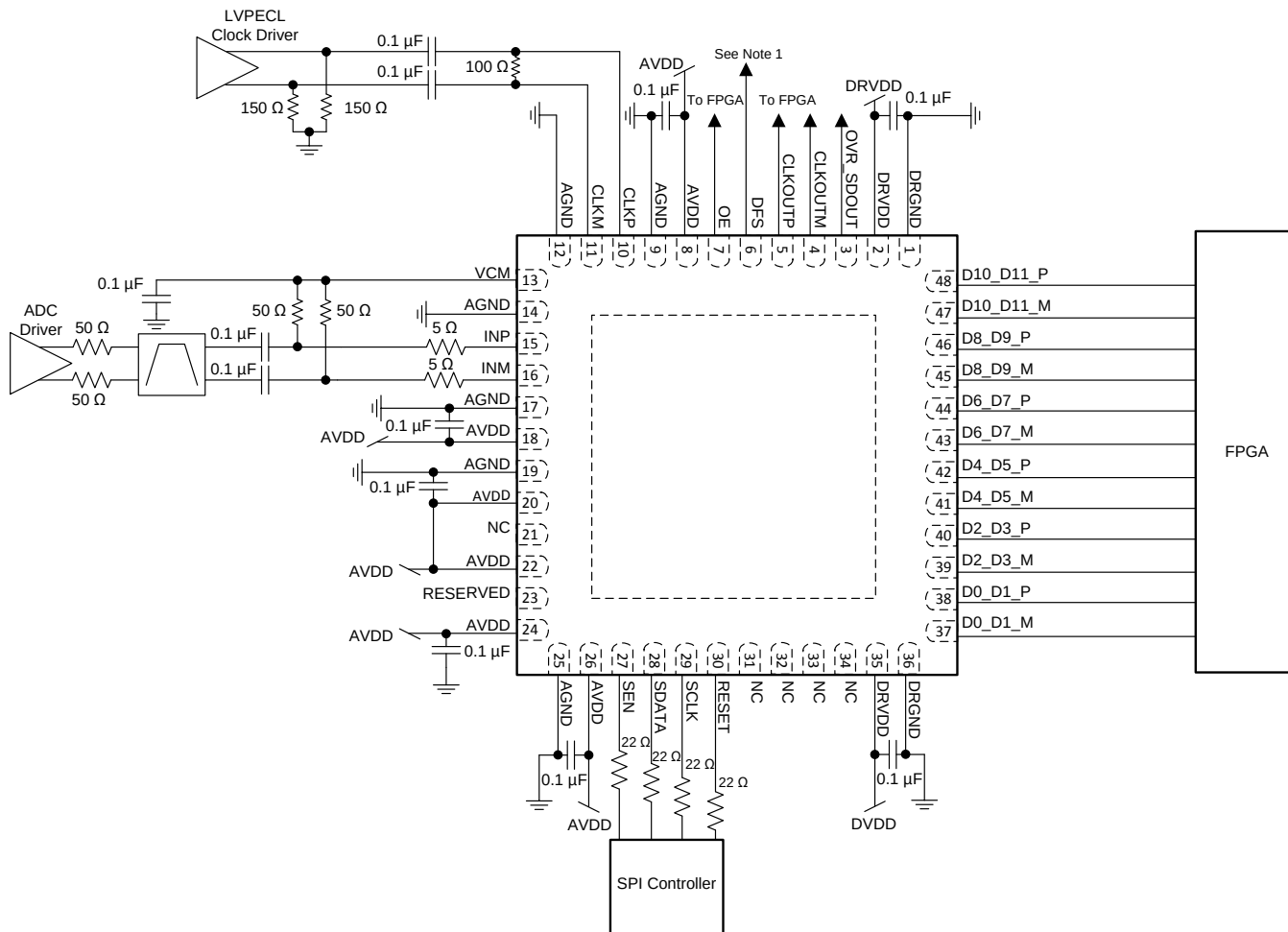


**Figure 51. Differential Clock Driving Circuit**

## 9.2 Typical Application

An example schematic for a typical application of the ADS4128 is shown in [Figure 52](#).



(1) Set per mode of operation.

**Figure 52. Example Schematic for ADS4128**

### 9.2.1 Design Requirements

Example design requirements are listed in [Table 28](#) for the ADC portion of the signal chain. These do not necessarily reflect the requirements of an actual system, but rather demonstrate why the ADS4128 may be chosen for a system based on a set of requirements.

**Table 28. Example Design Requirements for ADS4128**

| DESIGN PARAMETER         | EXAMPLE DESIGN REQUIREMENT                    | ADS4128 CAPABILITY                              |
|--------------------------|-----------------------------------------------|-------------------------------------------------|
| Sampling rate            | ≥184.32 Msps                                  | Max sampling rate: 200 Msps                     |
| Input frequency          | >190 MHz to accommodate full 2nd nyquist zone | Large signal –3 dB bandwidth: 400 MHz operation |
| SNR                      | >65dBFS at –1 dFBS 170 MHz                    | 69 dBFS at –1 dBFS, 170 MHz                     |
| SFDR                     | >80 dBc at –1 dFBS 170 MHz                    | 85 dBc at –1 dBFS, 170 MHz                      |
| Input full scale voltage | 2 Vpp                                         | 2 Vpp                                           |
| Overload recovery time   | < 3 clock cycles                              | 1 clock cycle                                   |
| Input full scale voltage | Parallel LVDS                                 | Parallel LVDS                                   |
| Overload recovery time   | < 250 mW per channel                          | 230 mW per channel                              |

## 9.2.2 Detailed Design Procedure

### 9.2.2.1 Analog Input

The analog input of the ADS4128 is typically driven by a fully differential amplifier. The amplifier must have sufficient bandwidth for the frequencies of interest. The noise and distortion performance of the amplifier affects the combined performance of the ADC and amplifier. The amplifier is often AC coupled to the ADC to allow both the amplifier and ADC to operate at the optimal common-mode voltages. The user can DC couple the amplifier to the ADC if required. An alternate approach is to drive the ADC using transformers. DC coupling cannot be used with the transformer approach.

### 9.2.2.2 Clock Driver

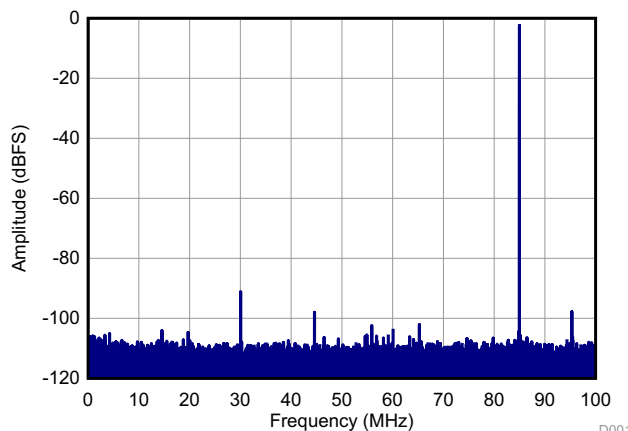
The ADS4128 should be driven by a high performance clock driver such as a clock jitter cleaner. The clock must have low noise to maintain optimal performance. LVPECL is the most common clocking interface, but LVDS and LVCMOS can also be used. Do not drive the clock input from an FPGA unless the noise degradation can be tolerated, such as for input signals near DC where the clock noise impact is minimal.

### 9.2.2.3 Digital Interface

The ADS4128 supports both LVDS and CMOS interfaces. The LVDS interface should be used for best performance when operating at maximum sampling rate. The LVDS outputs can be connected directly to the FPGA without any additional components. When using CMOS outputs, resistors must be placed in series with the outputs to reduce the output current spikes and limit the performance degradation. The resistors must be large enough to limit current spikes, but not so large as to significantly distort the digital output waveform. An external CMOS buffer must be used when driving distances greater than a few inches, to reduce ground bounce within the ADC.

## 9.2.3 Application Curve

Figure 53 shows the result of a 115-MHz signal sampled at 200 MHz captured by the ADS4128



SNR = 70.13 dBFS

SFDR= 83.75 dBFS

THD= 79.72 dBs

SINAD= 69.90 dBFS

**Figure 53. 115-MHz Signal Captured by ADS4128**

## 10 Power Supply Recommendations

The ADS4128 has two power supplies, one analog (AVDD) and one digital (DRVDD) supply. Both supplies have a nominal voltage of 1.8 V. The AVDD supply is noise sensitive and the digital supply is not.

### 10.1 Sharing DRVDD and AVDD Supplies

For best performance, the AVDD supply should be driven by a low-noise linear regulator (LDO) and separated from the DRVDD supply. AVDD and DRVDD can share a single supply, but they should be isolated by a ferrite bead and bypass capacitors, in a PI-filter configuration, at a minimum. The digital noise is concentrated at the sampling frequency and harmonics of the sampling frequency, and could contain noise related to the sampled signal. While developing schematics, leave extra placeholders for additional supply filtering.

### 10.2 Using DC/DC Power Supplies

DC/DC switching power supplies can be used to power DRVDD without issue. AVDD can be powered from a switching regulator. Noise and spurs on the AVDD power supply affect the SNR and SFDR of the ADC, and appear near DC and as a modulated component around the input frequency. If a switching regulator is used, it should have minimal voltage ripple. Supply filtering should be used to limit the amount of spurious noise at the AVDD supply pins. Extra placeholders should be placed on the schematic for additional filtering. Optimize filtering in the final system to achieve the desired performance. The choice of power supply ultimately depends on the system requirements. For instance, if very low phase noise is required, do not use a switching regulator.

### 10.3 Power Supply Bypassing

Because the ADS4128 already includes internal decoupling, minimal external decoupling can be used without loss in performance. Decoupling capacitors can help filter external power-supply noise; thus, the optimum number of capacitors depends on the actual application. A 0.1-uF capacitor is recommended near each supply pin. The decoupling capacitors should be placed very close to the converter supply pins.

## 11 Layout

### 11.1 Layout Guidelines

#### 11.1.1 Grounding

A single ground plane is sufficient to give good performance, provided the analog, digital, and clock sections of the board are cleanly partitioned. See the [ADS414x, ADS412x EVM User Guide \(SLWU067\)](#) for details on layout and grounding.

#### 11.1.2 Supply Decoupling

Because the ADS4128 already includes internal decoupling, minimal external decoupling can be used without loss in performance. Note that decoupling capacitors can help filter external power-supply noise, so the optimum number of capacitors depends on the actual application. The decoupling capacitors should be placed very close to the converter supply pins.

#### 11.1.3 Exposed Pad

In addition to providing a path for heat dissipation, the thermal pad is also electrically internally connected to the digital ground. Therefore, it is necessary to solder the exposed pad to the ground plane for best thermal and electrical performance. For detailed information, see application notes [QFN Layout Guidelines \(SLOA122\)](#) and [QFN/SON PCB Attachment \(SLUA271\)](#), both available for download at [www.ti.com](http://www.ti.com).

### 11.2 Layout Example

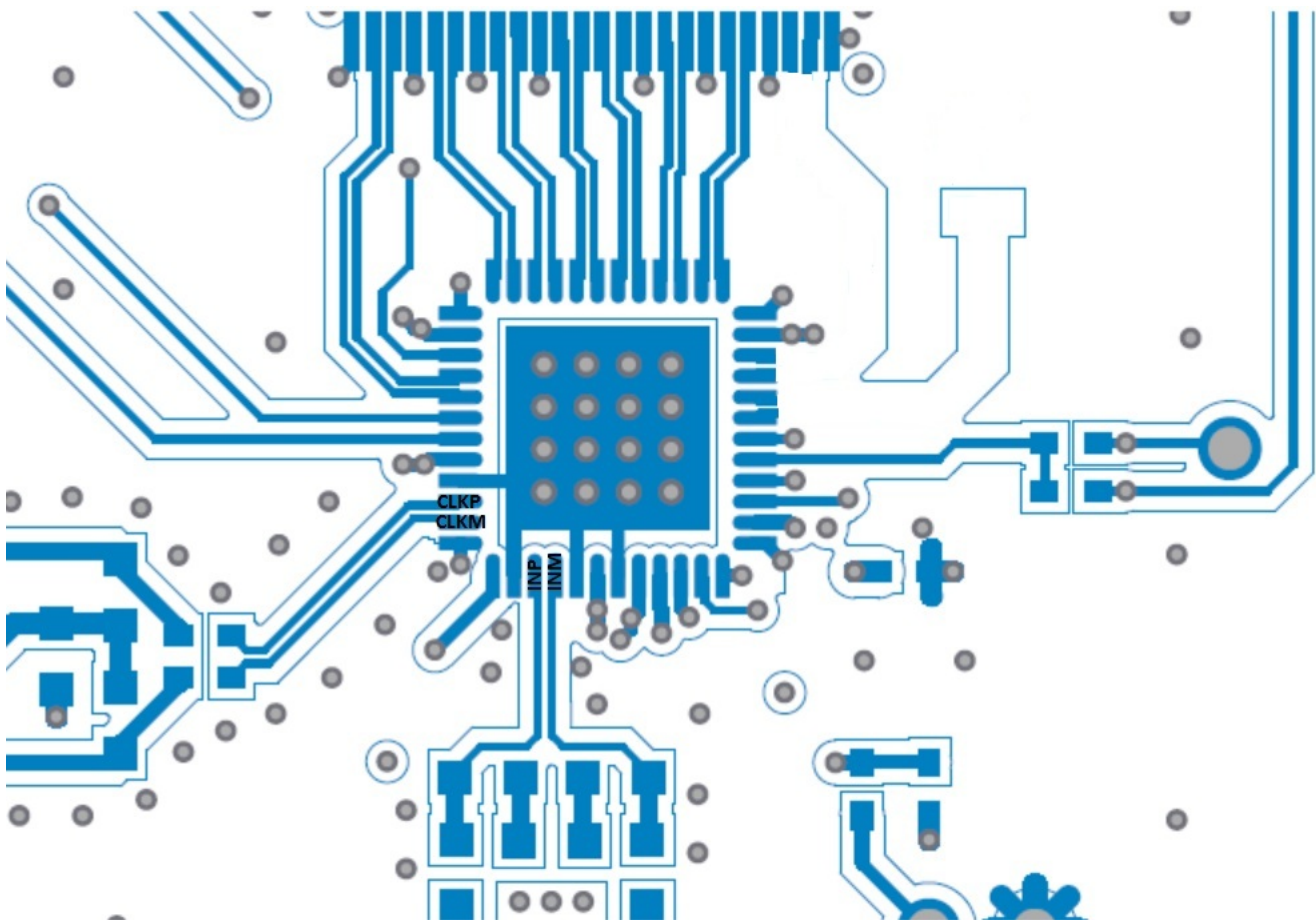


Figure 54. ADS4128EVM PCB Layout

## 12 Device and Documentation Support

### 12.1 Device Support

#### 12.1.1 Device Nomenclature

**Analog Bandwidth** – The analog input frequency at which the power of the fundamental is reduced by 3 dB with respect to the low-frequency value.

**Aperture Delay** – The delay in time between the rising edge of the input sampling clock and the actual time at which the sampling occurs. This delay is different across channels. The maximum variation is specified as aperture delay variation (channel-to-channel).

**Aperture Uncertainty (Jitter)** – The sample-to-sample variation in aperture delay.

**Clock Pulse Width/Duty Cycle** – The duty cycle of a clock signal is the ratio of the time the clock signal remains at a logic high (clock pulse width) to the period of the clock signal. Duty cycle is typically expressed as a percentage. A perfect differential sine-wave clock results in a 50% duty cycle.

**Maximum Conversion Rate** – The maximum sampling rate at which specified operation is given. All parametric testing is performed at this sampling rate unless otherwise noted.

**Minimum Conversion Rate** – The minimum sampling rate at which the ADC functions.

**Differential Nonlinearity (DNL)** – An ideal ADC exhibits code transitions at analog input values spaced exactly 1 LSB apart. The DNL is the deviation of any single step from this ideal value, measured in units of LSBs.

**Integral Nonlinearity (INL)** – The INL is the deviation of the ADC transfer function from a best fit line determined by a least squares curve fit of that transfer function, measured in units of LSBs.

**Gain Error** – Gain error is the deviation of the ADC actual input full-scale range from its ideal value. The gain error is given as a percentage of the ideal input full-scale range. Gain error has two components: error as a result of reference inaccuracy and error as a result of the channel. Both errors are specified independently as  $E_{GREF}$  and  $E_{GCHAN}$ .

To a first-order approximation, the total gain error is  $E_{TOTAL} \sim E_{GREF} + E_{GCHAN}$ .

For example, if  $E_{TOTAL} = \pm 0.5\%$ , the full-scale input varies from  $(1 - 0.5/100) \times FS_{ideal}$  to  $(1 + 0.5/100) \times FS_{ideal}$ .

**Offset Error** – The offset error is the difference, given in number of LSBs, between the ADC actual average idle channel output code and the ideal average idle channel output code. This quantity is often mapped into millivolts.

**Temperature Drift** – The temperature drift coefficient (with respect to gain error and offset error) specifies the change per degree Celsius of the parameter from  $T_{MIN}$  to  $T_{MAX}$ . It is calculated by dividing the maximum deviation of the parameter across the  $T_{MIN}$  to  $T_{MAX}$  range by the difference  $T_{MAX} - T_{MIN}$ .

**Signal-to-Noise Ratio** – SNR is the ratio of the power of the fundamental ( $P_S$ ) to the noise floor power ( $P_N$ ), excluding the power at dc and the first nine harmonics.

$$SNR = 10 \log_{10} \frac{P_S}{P_N} \quad (2)$$

SNR is either given in units of dBc (dB to carrier) when the absolute power of the fundamental is used as the reference, or dBFS (dB to full-scale) when the power of the fundamental is extrapolated to the converter full-scale range.

**Signal-to-Noise and Distortion (SINAD)** – SINAD is the ratio of the power of the fundamental ( $P_S$ ) to the power of all the other spectral components including noise ( $P_N$ ) and distortion ( $P_D$ ), but excluding dc.

$$SINAD = 10 \log_{10} \frac{P_S}{P_N + P_D} \quad (3)$$

SINAD is either given in units of dBc (dB to carrier) when the absolute power of the fundamental is used as the reference, or dBFS (dB to full-scale) when the power of the fundamental is extrapolated to the converter full-scale range.

## Device Support (continued)

**Effective Number of Bits (ENOB)** – ENOB is a measure of the converter performance as compared to the theoretical limit based on quantization noise.

$$\text{ENOB} = \frac{\text{SINAD} - 1.76}{6.02} \quad (4)$$

**Total Harmonic Distortion (THD)** – THD is the ratio of the power of the fundamental ( $P_S$ ) to the power of the first nine harmonics ( $P_D$ ).

$$\text{THD} = 10 \log^{10} \frac{P_S}{P_D} \quad (5)$$

THD is typically given in units of dBc (dB to carrier).

**Spurious-Free Dynamic Range (SFDR)** – The ratio of the power of the fundamental to the highest other spectral component (either spur or harmonic). SFDR is typically given in units of dBc (dB to carrier).

**Two-Tone Intermodulation Distortion** – IMD3 is the ratio of the power of the fundamental (at frequencies  $f_1$  and  $f_2$ ) to the power of the worst spectral component at either frequency  $2f_1 - f_2$  or  $2f_2 - f_1$ . IMD3 is either given in units of dBc (dB to carrier) when the absolute power of the fundamental is used as the reference, or dBFS (dB to full-scale) when the power of the fundamental is extrapolated to the converter full-scale range.

**DC Power-Supply Rejection Ratio (DC PSRR)** – DC PSRR is the ratio of the change in offset error to a change in analog supply voltage. The dc PSRR is typically given in units of mV/V.

**AC Power-Supply Rejection Ratio (AC PSRR)** – AC PSRR is the measure of rejection of variations in the supply voltage by the ADC. If  $\Delta V_{\text{SUP}}$  is the change in supply voltage and  $\Delta V_{\text{OUT}}$  is the resultant change of the ADC output code (referred to the input), then:

$$\text{PSRR} = 20 \log^{10} \frac{\Delta V_{\text{OUT}}}{\Delta V_{\text{SUP}}} \quad (\text{Expressed in dBc}) \quad (6)$$

**Voltage Overload Recovery** – The number of clock cycles taken to recover to less than 1% error after an overload on the analog inputs. This is tested by separately applying a sine wave signal with 6-dB positive and negative overload. The deviation of the first few samples after the overload (from the expected values) is noted.

**Common-Mode Rejection Ratio (CMRR)** – CMRR is the measure of rejection of variation in the analog input common-mode by the ADC. If  $\Delta V_{\text{CM\_IN}}$  is the change in the common-mode voltage of the input pins and  $\Delta V_{\text{OUT}}$  is the resulting change of the ADC output code (referred to the input), then:

$$\text{CMRR} = 20 \log^{10} \frac{\Delta V_{\text{OUT}}}{\Delta V_{\text{CM}}} \quad (\text{Expressed in dBc}) \quad (7)$$

**Crosstalk (only for multi-channel ADCs)** – This is a measure of the internal coupling of a signal from an adjacent channel into the channel of interest. It is specified separately for coupling from the immediate neighboring channel (near-channel) and for coupling from channel across the package (far-channel). It is usually measured by applying a full-scale signal in the adjacent channel. Crosstalk is the ratio of the power of the coupling signal (as measured at the output of the channel of interest) to the power of the signal applied at the adjacent channel input. It is typically expressed in dBc.

## 12.2 Documentation Support

### 12.2.1 Related Documentation

For related documentation, see the following:

- *QFN Layout Guidelines*, [SLOA122](#)
- *QFN/SON PCB Attachment*, [SLUA271](#)
- *ADS4226 Evaluation Module*, [SLWU067](#)

## 12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](http://e2e.ti.com), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

## 12.4 Trademarks

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## 12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2)            | Lead/Ball Finish<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|--------------------|------|----------------|----------------------------|-------------------------|----------------------|--------------|-------------------------|-------------------------|
| ADS4128IRGZR     | ACTIVE        | VQFN         | RGZ                | 48   | 2500           | Green (RoHS<br>& no Sb/Br) | NIPDAU                  | Level-3-260C-168 HR  | -40 to 85    | AZ4128                  | <a href="#">Samples</a> |
| ADS4128IRGZT     | ACTIVE        | VQFN         | RGZ                | 48   | 250            | Green (RoHS<br>& no Sb/Br) | NIPDAU                  | Level-3-260C-168 HR  | -40 to 85    | AZ4128                  | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBsolete:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

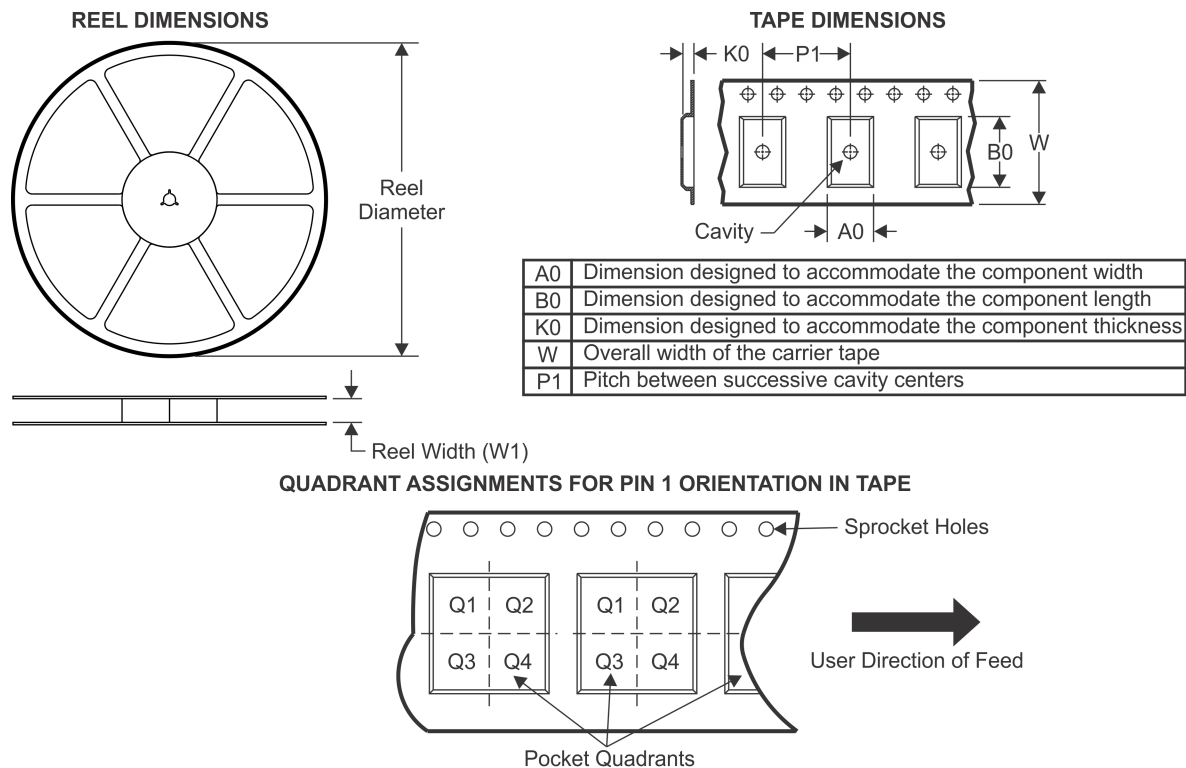
(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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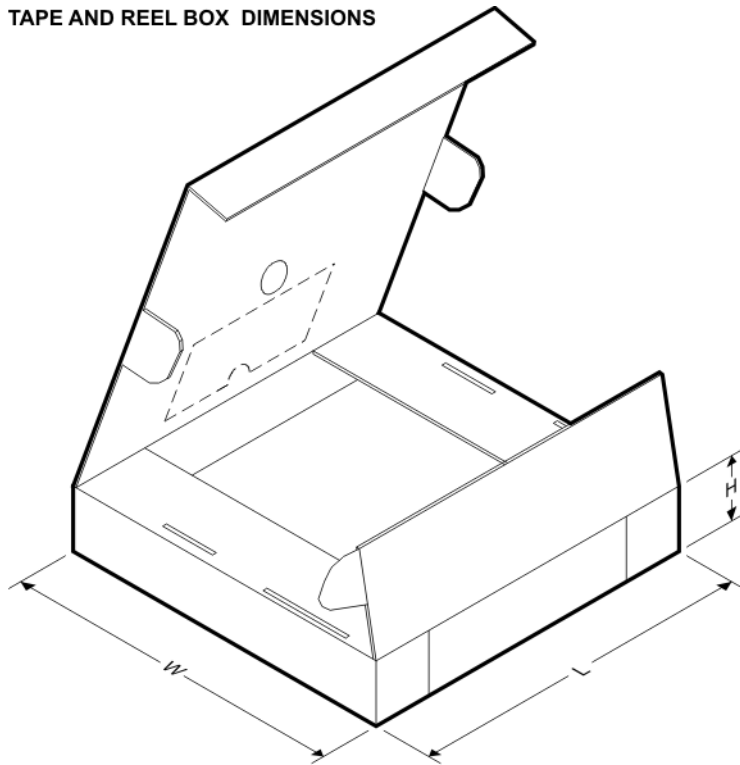


**TAPE AND REEL INFORMATION**


\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| ADS4128IRGZR | VQFN         | RGZ             | 48   | 2500 | 330.0              | 16.4               | 7.3     | 7.3     | 1.5     | 12.0    | 16.0   | Q2            |
| ADS4128IRGZT | VQFN         | RGZ             | 48   | 250  | 180.0              | 16.4               | 7.3     | 7.3     | 1.5     | 12.0    | 16.0   | Q2            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ADS4128IRGZR | VQFN         | RGZ             | 48   | 2500 | 350.0       | 350.0      | 43.0        |
| ADS4128IRGZT | VQFN         | RGZ             | 48   | 250  | 213.0       | 191.0      | 55.0        |

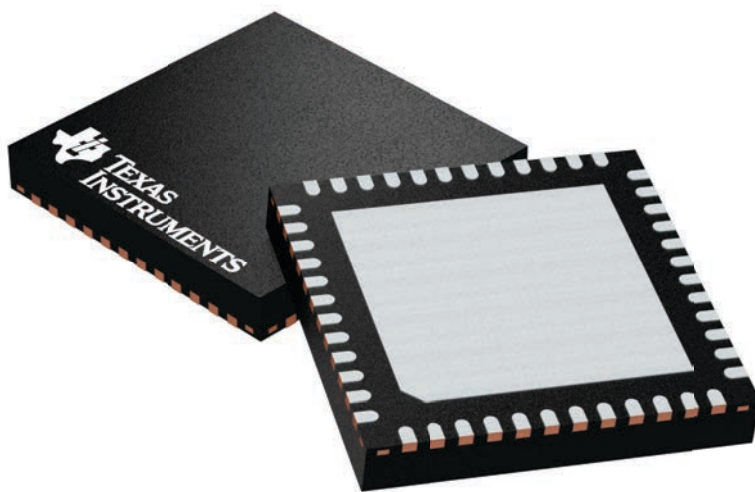
## GENERIC PACKAGE VIEW

**RGZ 48**

**VQFN - 1 mm max height**

7 x 7, 0.5 mm pitch

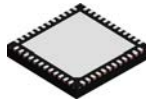
PLASTIC QUADFLAT PACK- NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4224671/A

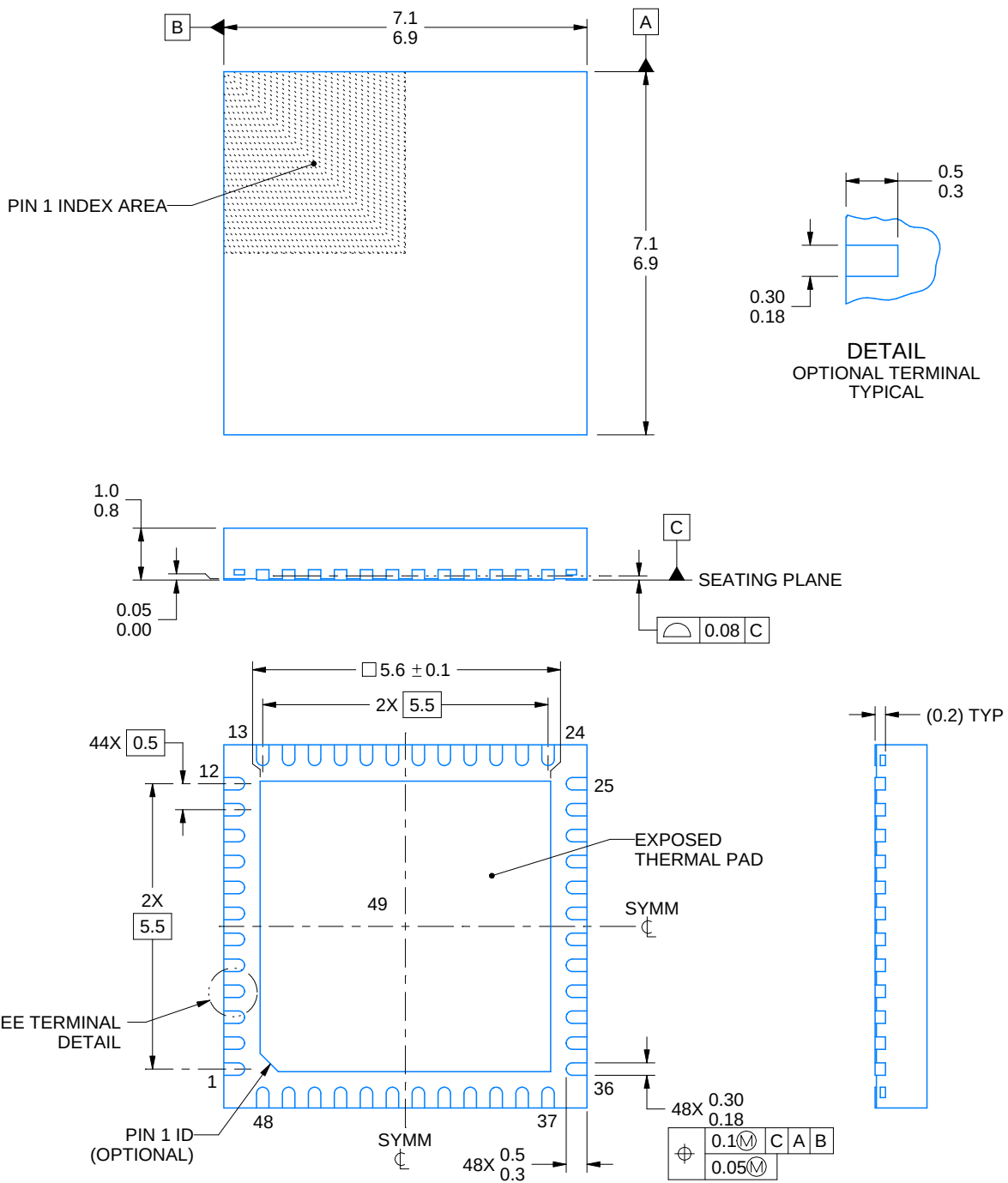
RGZ0048D



# PACKAGE OUTLINE

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



4219046/B 11/2019

## NOTES:

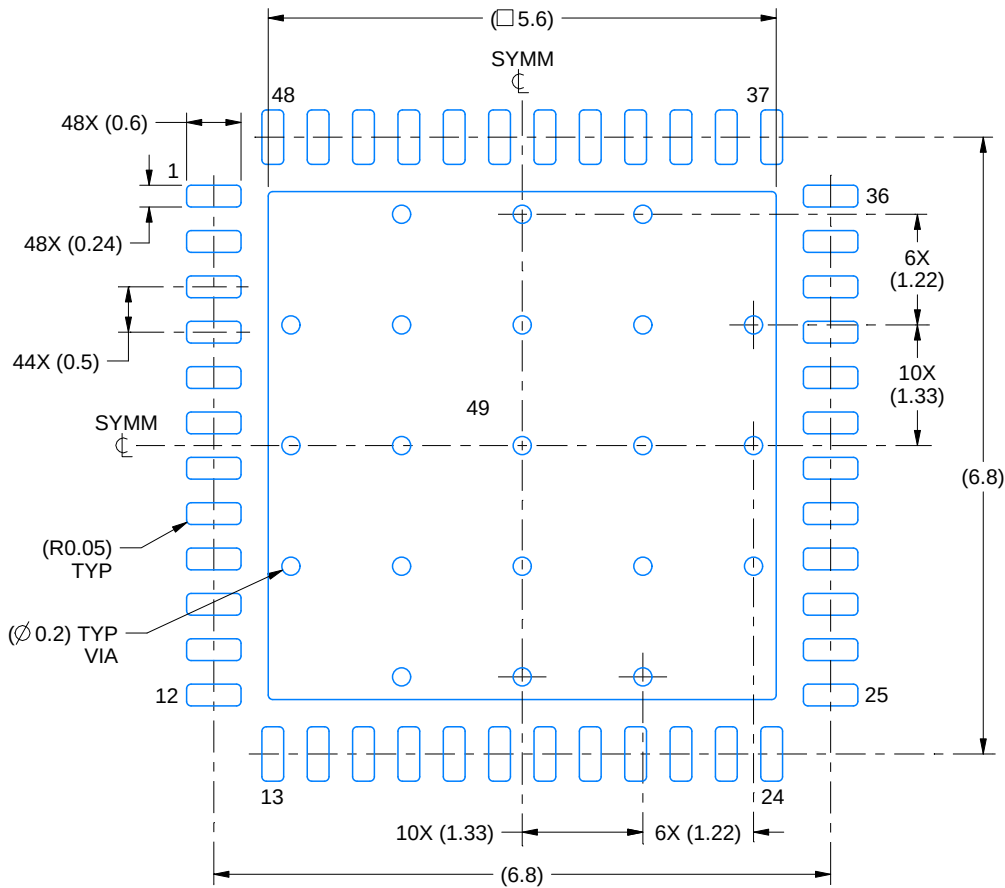
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

# EXAMPLE BOARD LAYOUT

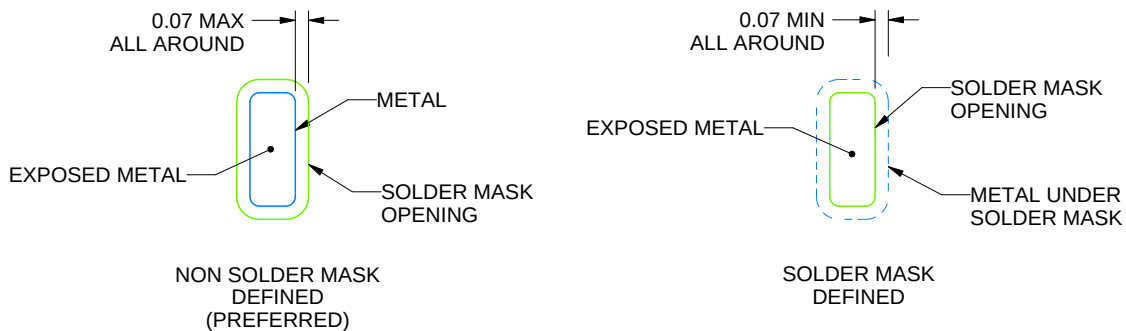
RGZ0048D

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:12X



SOLDER MASK DETAILS

4219046/B 11/2019

NOTES: (continued)

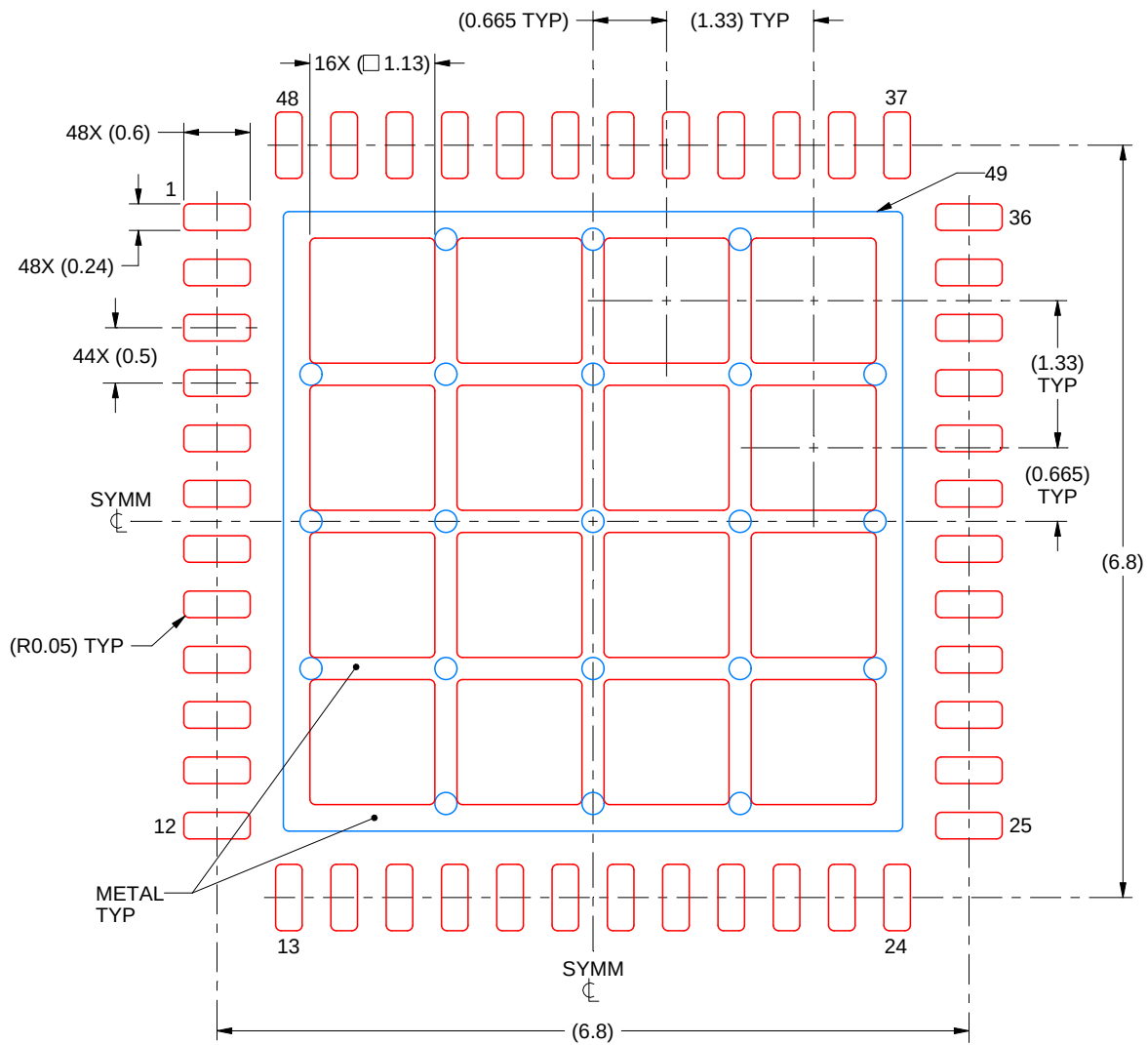
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/sluea271](http://www.ti.com/lit/sluea271)).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

# EXAMPLE STENCIL DESIGN

RGZ0048D

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



**SOLDER PASTE EXAMPLE**  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 49  
66% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE  
SCALE:15X

4219046/B 11/2019

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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